e2v

EV8AQ160 QUAD ADC

Datasheet

Main Features

- Quad ADC with 8-bit Resolution
 - 1.25 Gsps Sampling Rate in Four-channel Mode
 - 2.5 Gsps Sampling Rate in Two-channel Mode
 - 5 Gsps Sampling Rate in One-channel Mode
 - Built-in four-by-four Crosspoint Switch
- 2.5 GHz Differential Symmetrical Input Clock Required
- ADC Master Reset (LVDS)
- Double Data Rate Output Protocol
- LVDS Output Format
- Digital Interface (SPI) with Reset Signal
 - Selectable 1:1 or 1:2 Demultiplexed Outputs
 - Channel Mode Selection
 - 500 mVpp or 625 mVpp Analog Input (Differential AC or DC Coupled)
 - Selectable Bandwidth (Four Available Settings)
 - Gain Control (±18%)
 - Offset Control (±50 mV)
 - Phase Control (±14 ps Range)
 - Standby Mode (Full or Partial)
 - Binary or Gray Coding Selection
 - Test Mode
- Power Supplies: 3.3V and 1.8V (Outputs), 1.8V (Digital)
- Power Dissipation: 4.2W Total (1:1 DMUX Mode)
- EBGA380 Package (RoHS, 1.27 mm Pitch)

Performance

- Selectable Full Power Input Bandwidth (-3 dB) up to 2 GHz (4-/2-/1-channel modes)
- Channel-to-channel Isolation: >60 dB
- Four-channel Mode (Fsampling = 1.25 Gsps, -1 dBFS)
 - Fin = 100 MHz: ENOB = 7.5 bit, SFDR = 58 dBc, SNR = 46.5 dBc, DNL = ± 0.18 LSB, INL = ± 0.4 LSB
 - Fin = 620 MHz: ENOB = 7.3 bit, SFDR = 56 dBc, SNR = 45 dBc
- Two-channel Mode (Fsampling = 2.5 Gsps, -1 dBFS)
 - Fin = 100 MHz: ENOB = 7.5 bit, SFDR = 58 dBc, SNR = 46 dBc, DNL = ±0.14 LSB, INL = ±0.35 LSB
 - Fin = 620 MHz: ENOB = 7.2 bit, SFDR = 56 dBc, SNR = 44.5 dBc
- One-Channel Mode (Fsampling = 5 Gsps, Fin = 100 MHz, -1 dBFS)
 - Fin = 100 MHz: ENOB = 7.4 bit, SFDR = 58 dBc, SNR = 46 dBc, DNL = ± 0.12 LSB, INL = ± 0.27 LSB
 - Fin = 620 MHz: ENOB = 7.1 bit, SFDR = 56 dBc, SNR = 44 dBc
- BER: 10⁻¹⁶ at Full Speed



Screening

- Temperature Range for Packaged Device
- Commercial *C* Grade: 0°C < T_{amb} < 70°C

Applications

High-speed Oscilloscopes

1. Block Diagram

Figure 1-1.	Simplified Block Diagram
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2. Description

The Quad ADC is constituted by four 8-bit ADC cores which can be considered independently (fourchannel mode) or grouped by two cores (two-channel mode with the ADCs interleaved two by two or one-channel mode where all four ADCs are all interleaved).

All four ADCs are clocked by the same external input clock signal and controlled via an SPI (Serial Peripheral Interface). An analog multiplexer (cross-point switch) is used to select the analog input depending on the mode the Quad ADC is used.

The clock circuit is common to all four ADCs. This block receives an external 2.5 GHz clock (maximum frequency) and preferably a low jitter symmetrical signal. In this block, the external clock signal is then divided by two in order to generate the internal sampling clocks:

- In four-channel mode, the same 1.25 GHz clock is directed to all four ADC cores and T/H
- In two-channel mode, the in-phase 1.25 GHz clock is sent to ADC A or C and the inverted 1.25 GHz clock is sent to ADC B or D, while the analog input is sent to both ADCs, resulting in an interleaved mode with an equivalent sampling frequency of 2.5 Gsps

• In one-channel mode, the in-phase 1.25 GHz clock is sent to ADC A while the inverted 1.25 GHz clock is sent to ADC B, the in-phase 1.25 GHz clock is delayed by 90° to generate the clock for ADC C and the inverted 1.25 GHz clock is delayed by 90° to generate the clock for ADC D, resulting in an interleaved mode with an equivalent sampling frequency of 5 Gsps

Several adjustments for the sampling delay and the phase are included in this clock circuit to ensure a proper phase relation between the different clocks generated internally from the 2.5 GHz clock.

The *cross-point switch* (analog MUX) is common to all ADCs. It allows to select the analog input that has been chosen by the user:

- In four-channel mode, each analog input is sent to the corresponding ADC (AAI to ADC A, BAI to ADC B, CAI to ADC C and DAI to ADC D)
- In two-channel mode, one can consider that there are two independent ADCs composed of ADC A and B for the first one and of ADC C and D for the second one. The two analog inputs can be applied on AAI or on BAI for the first ADC (in which case, the signal is redirected internally to the second ADC of the pair that is, B or A respectively) and on CAI or DAI (in which case, the signal is redirected internally to the second ADC of the pair that is, D or C respectively)
- In one-channel mode, one analog input is chosen among AAI, BAI, CAI and DAI and then sent to all four ADCs





Figure 2-2. Two-channel Mode Configuration (Analog Input A and Analog Input C)





Figure 2-3. Two-channel Mode Configuration (Analog Input A and Analog Input D)





Figure 2-5. Two-channel Mode Configuration (Analog Input B and Analog Input D)



Figure 2-6. One-channel Mode Configuration



AAI, AAIN or BAI, BAIN or CAI, CAIN or DAI, DAIN

Note: For simplification purpose of the timer the temporal order of ports regarding sampling is A C B D, therefore samples order at output port is as follows:

A: N, N + 4, N + 8, N + 12... C: N + 1, N + 5, N + 9... B: N + 2, N + 6, N + 10... D: N + 3, N + 7, N + 11...

The *T/H* (Track and Hold) is located after the cross-point switch and before the ADC cores. This block is used to track the data when the internal sampling clock is low and to hold the data when the internal sampling clock is high. This stage has a gain of two.

The *ADC cores* are all the same for the four ADCs. They include a quantifier block as well as a fast logic block composed of regenerating latches and the binary/Gray decoding block. They can handle a maximum sampling rate of 1.25 Gsps.

The *SPI* block provides the digital interface for the digital controls of the ADCs. All the functions of the ADC are contained in the SPI registers and controlled via this SPI (channel selection, standby mode, binary or Gray coding, 1:1 or 1:2 DMUX, Offset Gain and Phase adjust etc.).

The *demultiplexer block* allows the user to divide the output data rate by a factor of 2 (1:2 DMUX, selectable via the SPI, in the Control register), hence decreasing the output rate to a maximum of 625 Msps instead of 1.25 Gsps in double data rate.

The *output buffers* are LVDS compatible. They should be terminated using a 100Ω external termination resistor. When the 1:1 DMUX ratio is selected, half of the output data buffers (*L* port data bits) is switched off to optimize the power consumption. In this mode, the *L* port data bits can then be left floating (no termination required), since both outputs of the buffers will deliver High logical level.

The *ADC SYNC buffer* is also LVDS compatible. When active, the SYNC signal makes the output clock signals go low. The output data are undetermined during the reset and until the output clock restarts.

When the SYNC signal is released, the output clock signals restart after TDR + pipeline delay + a certain number of input clock cycles which is programmed via the SPI in the SYNC register (from minimum delay to minimum delay + 15×2 input clock cycles).

A diode for the die junction temperature monitoring is implemented using a diode-mounted transistor but not connected to the die: both cathode and anode are accessible externally.

Eight *DACs for the gain and the offset controls* are included in the design and are addressed through the SPI:

- Offset DACs act close to the cross-point switch
- Gain DACs act on the biasing of the reference ladders of each ADC core

These DACs have a resolution of 8-bit and will allow the control via the SPI of the offset and gain of the ADCs:

- Gain adjustment on 256 steps, ±18% range
- Offset adjustment on 256 steps, ±50 mV range

Four DACs for fine phase control are included in the design and are addressed through the SPI, they have an 8-bit resolution, and a tuning range of ± 14 ps (1 step is about 110 fs).

3. Specifications

3.1 Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Positive supply voltage	V _{cc}	4	V
Positive digital supply voltage	V _{CCD}	2.5	V
Positive output supply voltage	V _{cco}	2.5	V
Maximum difference between V_{CC} and V_{CCO}	V_{CC} to V_{CCO}	1.6	V
Maximum difference between V_{CCD} and V_{CCO}	V_{CCD} to V_{CCO}	0.3	V
Analog input voltages	V _{IN} or V _{INN}	GND –0.3 (min) V _{CC} +0.3 (max)	v
Maximum difference between V_{IN} and V_{INN}	$V_{IN} - V_{INN}$	4	Vpp
Clock input voltage	V_{CLK} or V_{CLKN}	GND –0.3 (min) V _{CC} +0.3 (max)	v
Maximum difference between V_{CLK} and V_{CLKN}	$V_{CLK} - V_{CLKN}$	4	Vpp
Digital input voltage	V _D	V _{CC} + 0.3	V
Junction temperature	TJ	125	°C

ings

Note: Absolute maximum ratings are limiting values (referenced to GND = 0V), to be applied individually, while other parameters are within specified operating conditions. Long exposure to maximum rating may affect device reliability. All integrated circuits have to be handled with appropriate care to avoid damages due to ESD. Damage caused by inappropriate handling or storage could range from performance degradation to complete failure.

4. Recommended Conditions of Use

Table 4-1.	Recommended	Conditions of	of Use

Parameter	Symbol	Comments	Recommended Value	Unit
Positive supply voltage	V _{CC}	Analog core and SPI pads	3.3	V
Positive digital supply voltage	V _{CCD}	SPI core	1.8	V
Positive output supply voltage	V _{cco}	Output buffers	1.8	V
Differential analog input voltage (full scale)	V_{IN}, V_{INN} $V_{IN} - V_{INN}$		±250 500	mV mVpp
Digital CMOS input	V _D	V _{IL} V _{IH}	0 V _{CC}	v
Clock input power level	P _{CLK} P _{CLKN}		0	dBm
Clock frequency	F _{CLK}	For operation at 1.25 Gsps, 2.5 Gsps or 5 Gsps in four-channel, two-channel or one-channel mode respectively	≤2.5	GHz
Operating temperature range	T _{amb}	Commercial C grade	$0^{\circ}C < T_{amb} < 70^{\circ}C$	°C
Storage temperature	T _{stg}		–55 to 150	°C

5. Electrical Characteristics

Unless otherwise specified:

- $V_{CC} = 3.3V$, $V_{CCD} = 1.8V$, $V_{CCO} = 1.8V$
- -1 dBFS analog input (full scale input: $V_{IN} V_{INN} = 500 \text{ mVpp}$)
- Clock input differentially driven, analog input differentially driven
- Default mode: four-channel mode ON, binary output data format, digital interface ON, 1:2 DMUX ON, standby mode OFF, minimum bandwidth

 Table 5-1.
 Electrical Characteristics

Parameter	Symbol	Test Level	Min	Тур	Max	Unit	Notes
Resolution				8		Bit	
Power Requirements	·						
Power supply voltage Analog and SPI pads Digital Output	V _{cc} V _{ccD} V _{cco}		3.15 1.7 1.7	3.3 1.8 1.8	3.45 1.9 1.9	V V V	
Power supply current (DMUX 1:1) Analog and SPI pads Digital Output	I _{СС} I _{ССD} I _{ССО}	1,4		1.175 4.9 178	1.3 5.5 200	A mA mA	

Table 5-1. Electrical Characteristics (Continued)

Parameter	Symbol	Test Level	Min	Тур	Мах	Unit	Notes
Power supply current (DMUX 1:2) Analog and SPI pads Digital Output		1,4		1.25 4.9 300	1.35 5.5 350	A mA mA	
Power supply current (full standby mode, DMUX 1:1) Analog and SPI pads Digital Output and 3-Wire serial interface	I _{CC} I _{CCD} I _{CCO}	1, 4		136 4.9 29	150 5.5 45	mA mA mA	
Power supply current (full standby mode, DMUX 1:2) Analog and SPI pads Digital Output and 3-Wire serial interface	I _{CC} I _{CCD} I _{CCO}	1, 4		136 4.9 37	150 5.5 45	mA mA mA	
Power supply current (partial standby mode, DMUX 1:1) Analog and SPI pads Digital Output and 3-Wire serial interface	I _{CC} I _{CCD} I _{CCO}	1, 4		630 4.9 102	700 5.5 200	mA mA mA	
Power supply current (partial standby mode, DMUX 1:2) Analog and SPI pads Digital Output and 3-Wire serial interface	I _{CC} I _{CCD} I _{CCO}	1, 4		660 4.9 169	750 5.5 200	mA mA mA	
Power dissipation (max. power supplies) Full power (DMUX 1:1) Full power (DMUX 1:2) Partial standby (DMUX 1:1) Partial standby (DMUX 1:2) Full standby (DMUX 1:1) Full standby (DMUX 1:2)	P _D	1, 4		4.2 4.7 2.45 2.5 0.51 0.525	4.5 4.9 2.55 2.8 0.59 0.59	W W W W W	
Analog Inputs							
Full-scale input voltage range (differential mode)	V _{IN} V _{INN}	1,4		250 250		mVpp mVpp	
Full-scale input voltage range (differential mode) Extended range	V _{IN} V _{INN}	1,4		312.5 312.5		mVpp	
Input common mode (provided by CMIRefAB and CMIRefCD)	V _{ICM}	1,4	1.7	1.8	1.95	v	(1)
Analog input capacitance (die + package)	C _{IN}	5		0.5		pF	
Input resistance (differential)	R _{IN}	4	90	100	110	Ω	(2)

Table 5-1. Electrical Characteristics (Continued)

Parameter	Symbol	Test Level	Min	Тур	Мах	Unit	Notes		
Clock Inputs									
Source type			Diffe	erential Sinewa	ve				
Clock input common mode voltage									
(note: the clock should be AC coupled) for information only	V _{CM}	5		1.8		V			
Clock input power level (low phase noise sinewave input)100 Ω differential, AC coupled signal	P _{CLK}	4	-9	0	4	dBm			
Clock input swing (differential voltage) on each clock input	V _{CLK} , V _{CLKN}	4	150 150	450 450	565 565	mVpp mVpp			
Clock input capacitance (die + package)	C _{CLK}	5		0.5		pF			
Clock input resistance (differential)	R _{CLK}	4	85	113	115	Ω			
Clock jitter (max. allowed on clock source) For 1 GHz sinewave analog input	Jitter	4			500	fs			
Clock duty cycle requirement in one-channel mode for performance	Duty cycle	4	48	50	52	%			
Clock duty cycle requirement in two-channel mode for performance	Duty cycle	4	40	50	60	%			
Clock duty cycle requirement in four-channel mode for performance	Duty cycle	4	40	50	60	%			
SYNC, SYNCN Inputs									
Logic compatibility				LVDS					
Input voltages to be applied 50Ω transmission lines Logic Low Logic High Swing (each single-ended output) Common Mode	V _{IL} V _{IH} V _{IH} -V _{IL} V _{ICM}	1,4	1.4	330 1.2	1.1	V V mV V			
SYNC, SYNCN input capacitance	CSYNC	5		0.5		pF			
SYNC, SYNCN Input resistance	RSYNC	4	90	100	110	Ω			
SPI									
CMOS low level input voltage	V _{ilc}	1,4	0		$0.25 \times V_{CC}$	V	(3)		
CMOS high level input voltage	V _{ihc}	1,4	$0.75 \times V_{CC}$		V _{CC}	V	(3)		
CMOS low level of Schmitt trigger	Vtminusc	4			$0.35 imes V_{CC}$	V	(3)(4)		
CMOS high level of Schmitt trigger	Vtplusc	4	$0.65 \times V_{CC}$			V	(3)(4)		
CMOS Schmitt trigger hysteresis	Vhystc	4	$0.15 \times V_{CC}$			V	(5)(6)		
CMOS low level output voltage (lolc = 2 or 3 mA)	Volc	4			0.4	v	(5)(6)		

Table 5-1. Electrical Characteristics (Continued)

Parameter	Symbol	Test Level	Min	Тур	Max	Unit	Notes
CMOS high level output voltage (lohc = 2 or 3 mA)	Vohc	4	$0.8 \times V_{CC}$			v	(7)
CMOS low level input current (Vinc = 0 V)	lilc	1,4			30	nA	(8)
CMOS high level input current (Vinc = V_{CC})	lihc	1,4			165	nA	(8)
RESETN low level input current	lilc	1, 4		40	50	μA	(8)
RESETN high level input current	lihc	1, 4			10	nA	(8)
Digital Data and Data Ready Outputs							
Logic compatibility		1,4		LVDS			(9)
Output levels 50Ω transmission lines, 100Ω (2 × 50Ω) differentially terminated							
Logic low	V _{OL}	1,4		1.1	1.25	V	(9)
	V _{OH}		1.25	1.42		V	
Swing (each single-ended output)	V _{OH} – V _{OL}		250	320	450	mV	
	♥ OCM		1.125	1.20	1.575	v	
Gain central value		1.4		1			(10)
Gain error drift		4			0.1	%/°C	
Input offset voltage		1,4		0	-	mV	(10)
Four-channel Mode (Fsampling = 1.25 Gs	ps, Fin = 95	KHz, –1 dB	BFS), for Each	Channel With	out Calibratio	n	
DNLrms	DNLrms	1,4		0.07	0.15	LSB	(11)
Differential nonlinearity	DNL+	1,4		0.18	0.35	LSB	(11)
Differential nonlinearity	DNL-	1,4	-0.35	-0.18		LSB	(11)
INLrms	INLrms	1,4		0.18	0.4	LSB	(11)
Integral nonlinearity	INL+	1,4		0.4	0.9	LSB	(11)
Integral nonlinearity	INL-	1,4	-0.9	-0.4		LSB	(11)
Two-channel Mode (Fsampling = 2.5 Gsps	s, Fin = 95 K	Hz, –1 dBF	S), for Each C	hannel Withou	ut Calibration		
DNLrms	DNLrms	1,4		0.05	0.15	LSB	(11)
Differential nonlinearity	DNL+	1,4		0.14	0.35	LSB	(11)
Differential nonlinearity	DNL-	1,4	-0.35	-0.14		LSB	(11)
INLrms	INLrms	1,4		0.14	0.4	LSB	(11)
Integral nonlinearity	INL+	1,4		0.35	0.9	LSB	(11)
Integral nonlinearity	INL-	1,4	-0.9	-0.35		LSB	(11)
One-channel Mode (Fsampling = 5 Gsps,	Fin = 95 KHz	z, –1 dBFS)	Without Cali	bration			
DNLrms	DNLrms	1,4		0.04	0.15	LSB	(11)
Differential nonlinearity	DNL+	1,4		0.12	0.35	LSB	(11)
Differential nonlinearity	DNL-	1,4	-0.35	-0.12		LSB	(11)

Table 5-1. Electrical Characteristics (Continued)

Parameter	Symbol	Test Level	Min	Тур	Max	Unit	Notes
INLrms	INLrms	1,4		0.11	0.4	LSB	(11)
Integral nonlinearity	INL+	1,4		-0.27	0.9	LSB	(11)
Integral nonlinearity	INL-	1,4	-0.9	0.27		LSB	(11)

Notes: 1. The input common mode voltage is delivered via the CMIRefAB and CMIRefCD signals for channels A and B, and C and D respectively. The minimum load allowed on these signals is $2.5 \text{ k}\Omega$ (optimal load = $5 \text{ k}\Omega$ to $10 \text{ k}\Omega$).

- 2. The input resistance can be trimmed via register at address 0x13 to reach the 100Ω value.
- 3. A minimum noise margin of $0.05 \times V_{CC}$ is taken for Schmitt trigger input threshold switching levels compared to Vilc and Vihc.
- 4. Parameters specified for characterization purpose only, not valid at chip level specification.
- 5. Takes in account 200 mV voltage drop in both supply lines.
- 6. Iolc and lohc values are source/sink currents in worst case conditions reflected in the name of the IO cell.
- 7. Leakage values related to ESD protection scheme and must be checked against leakage current observed with this process.
- 8. Internal 75 k Ω pull up.
- 9. Differential output buffers impedance = 100Ω differential.
- 10. Offset and Gain central values can be set to 0 mV and 1 respectively using the gain and offset adjustments provided in the SPI.
- 11. Values obtained without calibration. With calibration, IINLI values can be lowered to ±0.25 LSB typ (± 0.5 LSB max).

5.1 AC Electrical Characteristics

Unless otherwise specified:

- $V_{CC} = 3.3V$, $V_{CCD} = 1.8V$, $V_{CCO} = 1.8V$
- -1 dBFS analog input (full scale Input: $V_{IN} V_{INN} = 500 \text{ mVpp}$)
- · Clock input differentially driven; analog input differentially driven
- Default mode: four-channel mode ON, binary output data format, digital interface ON, 1:2 DMUX ON, standby mode OFF minimum bandwidth

Table 5-2. AC Electrical Characteristics

Parameter	Symbol	Test Level	Min	Тур	Max	Unit	Notes
AC Analog Inputs							
Full power input bandwidth							
Full setting (BW = 11 in register 0x01) Nominal setting (BW = 10 in register 0x01) Reduced setting (BW = 01 in register 0x01) Min setting (BW = 00 in register 0x01, default mode)	FPBW	4	1.5 1.3 400 300	2 1.5 600 500		GHz GHz MHz MHz	(1)
Gain flatness (over any 500 MHz in full bandwidth setting, $BW = 11$ in register 0x01)	GF	4			1	dB	
Input voltage standing wave ratio	VSWR	4			1.6		(2)
Crosstalk (Fin = 620 MHz)		1,4	55	62		dB	

Table 5-2. AC Electrical Characteristics (Continued)

Parameter	Symbol	Test Level	Min	Тур	Max	Unit	Notes	
Dynamic Performance, Four-channel Mode (Fsampling = 1.25 Gsps, –1 dBFS) for Each Channel								
Effective number of bits Fs = 1.25 Gsps Fin = 10 MHz Fs = 1.25 Gsps Fin = 100 MHz Fs = 1.25 Gsps Fin = 620 MHz	ENOB	1,4	7.2 7.2 7	7.5 7.5 7.3		Bit	(3)	
Signal-to-noise ratio Fs = 1.25 Gsps Fin = 10 MHz Fs = 1.25 Gsps Fin = 100 MHz Fs = 1.25 Gsps Fin = 620 MHz	SNR	1,4	45 45 43	46.5 46.5 45		dBc	(3)	
Total harmonic distortion(25 Harmonics)Fs = 1.25 GspsFin = 10 MHzFs = 1.25 GspsFin = 100 MHzFs = 1.25 GspsFin = 620 MHz	ITHDI	1,4	46 46 46	56 56 54		dBc	(3)	
Spurious free dynamic range Fs = 1.25 Gsps Fin = 10 MHz Fs = 1.25 Gsps Fin = 100 MHz Fs = 1.25 Gsps Fin = 620 MHz	ISFDRI	1,4	48 48 48	59 58 56		dBc	(3)	
Two-tone third order intermodulation distortion Fs = 1.25 Gsps Fin1 = 490 MHz Fin2 = 495 MHz [7dBFS]	IIMD3I	4		50		dBFS	(3)	
Dynamic Performance Two-channel Mode (Fsam	oling = 2.5 C	Gsps, −1 dE	SFS) for Ead	ch Channel	T	ſ	1	
Effective number of bits Fs = 1.25 Gsps Fin = 10 MHz Fs = 1.25 Gsps Fin = 100 MHz Fs = 1.25 Gsps Fin = 620 MHz	ENOB	1,4	7.2 7.2 6.9	7.5 7.5 7.2		Bit	(3)	
Signal-to-noise ratio Fs = 1.25 Gsps Fin = 10 MHz Fs = 1.25 Gsps Fin = 100 MHz Fs = 1.25 Gsps Fin = 620 MHz	SNR	1, 4	44 44 42	46 46 44.5		dBc	(3)	
Total harmonic distortion (25 Harmonics) Fs = 1.25 Gsps Fin = 10 MHz Fs = 1.25 Gsps Fin = 100 MHz Fs = 1.25 Gsps Fin = 620 MHz	ITHDI	1,4	48 48 48	59 58 55		dBc	(3)	
Spurious-free dynamic range Fs = 1.25 Gsps Fin = 10 MHz Fs = 1.25 Gsps Fin =100 MHz Fs = 1.25 Gsps Fin = 620 MHz	ISFDRI	1,4	49 48 48	59 58 56		dBc	(3)	
Two-tone third order intermodulation distortion Fs = 2.5 Gsps Fin1 = 490 MHz Fin2 = 495 MHz [7dBFS]	IIMD3I	4		50		dBFS	(3)	

Table 5-2. AC Electrical Characteristics (Continued)

Parameter	Symbol	Test Level	Min	Тур	Max	Unit	Notes		
Dynamic Performance – One-channel Mode (Fsampling = 5 Gsps, –1 dBFS)									
Effective number of bits									
Fs = 5 Gsps Fin = 10 MHz	ENOB	1 /	7	7.4		Bit	(3)		
Fs = 5 Gsps Fin = 100 MHz	LINOD	1,4	7	7.4		Dit			
Fs = 5 Gsps Fin = 620 MHz			6.8	7.1					
Signal-to-noise ratio									
Fs = 5 Gsps Fin = 10 MHz	SND	1 /	43	46		dPa	(3)		
Fs = 5 Gsps Fin = 100MHz	SINH	n 1,4	43	46		UDC	(-)		
Fs = 5 Gsps Fin = 620 MHz			41	44					
Total harmonic distortion (25 harmonics)									
Fs = 5 Gsps Fin = 10 MHz		- 4	50	62		۹De	(3)		
Fs = 5 Gsps Fin = 100 MHz	IIHDI	1,4	50	60		abc	(-)		
Fs = 5 Gsps Fin = 620 MHz			48	56					
Spurious free dynamic range									
Fs = 5 Gsps Fin = 10 MHz		- 4	48	59		۹De	(3)		
Fs = 5 Gsps Fin = 100 MHz	ISFURI	1,4	48	58		abc	(-)		
Fs = 5 Gsps Fin = 620 MHz			48	58					
Two-tone third order Intermodulation distortion									
Fs = 5 Gsps		4		40			(3)		
Fin1 = 490 MHz		4		40		UDFS	N-7		
Fin2 = 495 MHz [-7dBFS]									

Notes: 1. It is recommended to use the ADC in reduced bandwidth mode in order to minimize the noise in the ADC when allowed by the application. Same bandwidth in interleaving mode and non interleaving mode (4-/2-/1-channel modes).

2. Specified from DC up to 2.5 GHz input signal. Input VSWR is measured on a soldered device. It assumes an external $50\Omega \pm 2\Omega$ controlled impedance line, and a 50Ω driving source impedance (S₁₁ < -30 dB).

3. All the figures provided at Fin = 10 and 100 MHz were obtained using the ADC in minimum band mode (bit 9 = 0 and bit 8 = 0 of register at address 0x01). The ones provided at Fin = 620 MHz were obtained using the ADC nominal band mode (bit 9 = 1 and bit 8 = 0 of register at address 0x01).

5.2 Transient and Switching Performances

Table 5-3.Transient and Switching Performances Fc = 2.5 GHz

Parameter	Symbol	Test Level	Min	Тур	Max	Unit	Notes
Transient Performance							
Bit Error Rate	BER	4		10 ⁻¹⁶		Error/ sample	(1)
ADC settling time $(V_{IN} - V_{INN} = 400 \text{ mVpp})$ in full BW mode	тѕ	4		2		ns	
Overvoltage recovery time	ORT	4		2		ns	

Table 5-3.Transient and Switching Performances Fc = 2.5 GHz (Continued)

Parameter	Symbol	Test Level	Min	Тур	Max	Unit	Notes
ADC step response rise/fall time (10% to 90%) at Fc = 2.5 GHz		4		200	220	ps	
Overshoot		4			2	%	
Ringback		4			2	%	
Switching Performance and Characteristic	S	I		L.	I	ll.	
Clock frequency	F _{CLK}	4	400		2500	MHz	(2)(3)
Sampling frequency (for each channel)							
Four-channel mode Two-channel mode One-channel mode	Fs		200 400 800		1250 2500 5000	Msps Msps Msps	
Minimum clock pulse width (high)	TC1	4	160			ps	
Minimum clock pulse width (low)	TC2	4	160			ps	
Aperture delay	ТА	4		40		ps	(2)
ADC aperture uncertainty (internal)	Jitter	4		300		fs rms	(2)
Output rise time for DATA (20% to 80%)	TR	4	150	200	250	ps	(4)
Output fall time for DATA (20% to 80%)	TF	4	150	200	250	ps	
Output rise time for DATA READY (20% to 80%)	TR	4	150	200	250	ps	(4)
Output fall time for DATA READY (20% to 80%)	TF	4	150	200	250	ps	
Data output delay	TOD	4		3		ns	(5)
	TDR	4		3		ns	(5)
Data ready output delay	ITOD – TDRI	4			50	ps	(5)
Data ready pipeline delay <i>Four-Channel Mode</i> 1:1 DMUX 1:2 DMUX				10 15			
<i>Two-Channel Mode</i> 1:1 DMUX 1:2 DMUX	TPD	4		11 16		Clock Cycles	(6)
<i>One-Channel Mode</i> 1:1 DMUX 1:2 DMUX				11 16			

Parameter	Symbol	Test Level	Min	Тур	Max	Unit	Notes
Output data pipeline delay <i>Four-Channel Mode</i> 1:1 DMUX port AH, BH, CH, DH				9			
1:2 DMUX port AH, BH, CH, DH 1:2 DMUX port AL, BL, CL, DL				11 13			
<i>Two-Channel Mode</i> 1:1 DMUX port AH, CH 1:1 DMUX port BH, DH				10 9			
1:2 DMUX port AH, CH 1:2 DMUX port AL, CL 1:2 DMUX port BH, DH 1:2 DMUX port BL, DL	TPD	4		12 14 11 13		Clock	
One-Channel Mode 1:1 DMUX port AH 1:1 DMUX port BH 1:1 DMUX port CH 1:1 DMUX port DH				10 9 9.5 8.5		cycles	
1:2 DMUX port AL 1:2 DMUX port BL 1:2 DMUX port CL 1:2 DMUX port DL 1:2 DMUX port AH 1:2 DMUX port BH 1:2 DMUX port CH 1:2 DMUX port DH				14 13 13.5 12.5 12 11 11.5 10.5			
Output data to data ready propagation Delay 1:1 DMUX 1:2 DMUX	TD1	4	400 650	500 850	600 1050	ps ps	(7)
Data ready to output data propagation delay 1:1 DMUX 1:2 DMUX	TD2	4	200 550	300 750	400 950	ps ps	(7)
Data ready reset delay	TRDR			3.5 clock cycles + 1.5 ns		ns	
Minimum SYNC pulse width	TSYNC		2 x Tclock				(8)
SYNC setup time	Tsetup			40		ps	(8)
SYNC Hold time	Thold			0		ps	(8)

Table 5-3. Transient and Switching Performances Fc = 2.5 GHz (Continued)

Notes: 1. Output error amplitude < ± 6 lsb. Fs = 1.25 Gsps T_J = 110°C.

- 2. See "Definition of Terms" on page 70.
- 3. The clock frequency lower limit is due to the gain.
- 50Ω // C_{LOAD} = 2 pF termination (for each single-ended output). Termination load parasitic capacitance derating value: 50 ps/pF (ECL).

- 5. TOD and TDR propagation times are defined at package input/outputs. They are given for reference only.
- 6. Data ready pipeline delay is given from data N clock rising edge to first change in XDR signal (with X = A, B, C, D).
- 7. Values for TD1 and TD2 are given for a 2.5 GHz external clock frequency (50% duty cycle). For different sampling rates, apply the following formula: TD1 = T/2 +(ITOD-TDRI) and TD2 = T/2 +(ITOD-TDRI), where T= clock period. This places the rising edge (True-False) of the differential data ready signal in the middle of the output data valid window. This gives maximum setup and hold times for external data acquisition.
- Tclock = external clock period.
 SYNC cannot change less than 40 ps before CLK has a rising edge
 SYNC can change 0 ps after CLK has a rising edge
 SYNC must be high for 2 CLK (external clock) rising edges

5.3 Test Level Explanation

1	100% production tested at +25°C ⁽¹⁾ (for C temperature range ⁽²⁾).
2	100% production tested at +25°C ⁽¹⁾ , and sample tested at specified temperatures (for <i>V</i> temperature ranges ⁽²⁾).
3	Sample tested only at specified temperatures.
4	Parameter is guaranteed by design and characterization testing (thermal steady-state conditions at specified temperature).
5	Parameter is a typical value only guaranteed by design only.
6	100% production tested over specified temperature range (for B/Q temperature range ⁽²⁾).

Table 5-4.Explanation of Test Levels

Only minimum and maximum values are guaranteed (typical values are resulting from characterization).

Notes: 1. Unless otherwise specified.

2. If applicable, please refer to "Ordering Information" on page 78".

5.4 Timing Information

For the information on the reset sequence (using SYNC, SYNCN signals, please refer to Section 8.1 "ADC Synchronization Signal (SYNC, SYNCN)" on page 44).





Notes: 1. X refers to A, B, C and D. 2. Not to scale.











Notes: 1. In two-channel mode, the two analog inputs can be applied on: (AAL AAIN) and (CAL CAIN) in which case the outputs corresponding to (AAL AAIN) will be

(AAI, AAIN) and (CAI, CAIN), in which case, the outputs corresponding to (AAI, AAIN) will be on AHD0...AHD7 and BHD0...BHD7 and the ones corresponding to (CAI, CAIN) on CHD0...CHD7 and DHD0...DHD7

or (AAI, AAIN) and (DAI, DAIN), in which case, the outputs corresponding to (AAI, AAIN) will be on AHD0...AHD7 and BHD0...BHD7 and the ones corresponding to (DAI, DAIN) on CHD0...CHD7 and DHD0...DHD7 or (BAI, BAIN) and (CAI, CAIN), in which case, the outputs corresponding to (BAI, BAIN) will be on AHD0...AHD7 and BHD0...BHD7 and the ones corresponding to (CAI, CAIN) on CHD0...CHD7 and DHD0...DHD7

or (BAI, BAIN) and (DAIN, DAIN), in which case, the outputs corresponding to (BAI, BAIN) will be on AHD0...AHD7 and BHD0...BHD7 and the ones corresponding to (DAI, DAIN) on CHD0...CHD7 and DHD0...DHD7.





Notes: 1. In two-channel mode, the two analog inputs can be applied on:

(AAI, AAIN) and (CAI, CAIN), in which case, the outputs corresponding to (AAI, AAIN) will be on ALD0...ALD7, AHD0...AHD7 and BLD0...BLD7, BHD0...BHD7 and the ones corresponding to (CAI, CAIN) on CLD0...CLD7, CHD0...CHD7 and DLD0...DLD7, DHD0...DHD7;

or (AAI, AAIN) and (DAI, DAIN), in which case, the outputs corresponding to (AAI, AAIN) will be on ALD0...ALD7, AHD0...AHD7 and BLD0...BLD7, BHD0...BHD7 and the ones corresponding to (DAI, DAIN) on CLD0...CLD7, CHD0...CHD7 and DLD0...DLD7, DHD0...DHD7;

or (BAI, BAIN) and (CAI, CAIN), in which case, the outputs corresponding to (BAI, BAIN) will be on ALD0...ALD7, AHD0...AHD7 and BLD0...BLD7, BHD0...BHD7 and the ones corresponding to (CAI, CAIN) on CLD0...CLD7, CHD0...CHD7 and DLD0...DLD7, DHD0...DHD7;

or (BAI, BAIN) and (DAIN, DAIN), in which case, the outputs corresponding to (BAI, BAIN) will be on ALD0...ALD7, AHD0...AHD7 and BLD0...BLD7, BHD0...BHD7 and the ones corresponding to (DAI, DAIN) on CLD0...CLD7, CHD0...CHD7 and DLD0...DLD7, DHD0...DHD7.



Figure 5-5. ADC Timing in One-channel Mode, 1:1 DMUX Mode

Notes: 1. In one-Channel mode, the analog input can be applied on (AAI,AAIN), (BAI, BAIN), (CAI, CAIN) or (DAI, DAIN). The choice is made via the SPI in the control register.



Figure 5-6. ADC Timing in One-channel Mode, 1:2 DMUX Mode

Notes: 1. In one-channel mode, the analog input can be applied on (AAI,AAIN), (BAI, BAIN), (CAI, CAIN) or (DAI, DAIN). The choice is made via the SPI in the control register.

5.5 Coding

		Digital Out	out		
Differential Analog Input	Voltage Level	Binary MSBLSB Out-of-range	Gray MSBLSB Out-of-range		
+250 mV	>Top end of full scale + 1/2 LSB	11111111 1	10000000 1		
+250 mV	Top end of full scale + $\frac{1}{2}$ LSB	11111111 0 11111110 0	10000000 0		
+248.05 mV	Top end of full scale - $\frac{1}{2}$ LSB		10000001 0		
+125 mV	3/4 full scale + ½ LSB	11000000 0	10100000 0 11100000 0		
+123.05 mV	3/4 full scale – ½ LSB	10111111 0			
+0.976 mV	Mid scale + ½ LSB	10000000 0	1 1 0 0 0 0 0 0		
–0.976 mV	Mid scale – ½ LSB	01111111 0	0 1 0 0 0 0 0 0		
–123.05 mV	1/4 full scale + ½ LSB	01000000 0	01100000 0		
–125 mV	1/4 full scale – ½ LSB	00111111 0	00100000 0		
–248.05 mV	Bottom end of full scale + ½ LSB	00000001 0	00000001 0		
–250 mV	Bottom end of full scale – ½ LSB	00000000 0	00000000 0		
< –250 mV	< Bottom end of full scale -1/2 LSB	00000000 1	00000000 1		

Table 5-5.ADC Coding Table

6. Pin Description

6.1 Pinout View (Bottom View)

AD	GND	VCC	BLD6	BLD7	BLOR	GND	DiodA	tdreadyp	tdcop	trigp	SYNCP	CLK	CLKN	scan0	scan2	sclk	mosi	Res50	GND	CLOR	CLD7	CLD6	VCC	GND
AC	GND	VCC	BLD6N	BLD7N	BLORN	GND	DiodC	tdreadyn	tdcon	trign	SYNCN	GND	GND	scan1	rstn	csn	miso	Res62	GND	CLORN	CLD7N	CLD6N	VCC	GND
AB	BHOR	BHORN	VCC	GND	VCC	GND	VCC	GND	GND	VCC	VCCD	GND	GND	VCC	VCC	GND	GND	VCC	GND	VCC	GND	VCC	CHORN	CHOR
AA	BHD7	BHD7N	VCC	GND	VCCO	VCC	VCC	GND	GND	vcc	VCCD	GND	GND	VCC	VCC	GND	GND	VCC	VCC	VCCO	GND	VCC	CHD7N	CHD7
Y	BHD6	BHD6N	VCCO	GND	GND	VCCO	VCC	GND	GND	VCC	VCCD	GND	GND	VCC	VCC	GND	GND	VCC	VCCO	GND	GND	VCCO	CHD6N	CHD6
W	BHD5	BHD5N	VCCO	GND	GND															GND	GND	VCCO	CHD5N	CHD5
V	BHD4	BHD4N	BLD5	BLD5N	GND															GND	CLD5N	CLD5	CHD4N	CHD4
U	BHD3	BHD3N	BLD4	BLD4N	VCCO															VCCO	CLD4N	CLD4	CHD3N	CHD3
т	BHD2	BHD2N	BLD3	BLD3N	GND											_				GND	CLD3N	CLD3	CHD2N	CHD2
R	BHD1	BHD1N	BLD2	BLD2N	VCC															VCC	CLD2N	CLD2	CHD1N	CHD1
Ρ	BHD0	BHD0N	BLD1	BLD1N	GND															GND	CLD1N	CLD1	CHD0N	CHD0
N	BDR	BDRN	BLD0	BLD0N	VCC															VCC	CLD0N	CLD0	CDRN	CDR
М	ADR	ADRN	ALD0	ALDON	VCC															VCC	DLDON	DLD0	DDRN	DDR
L	AHD0	AHDON	ALD1	ALD1N	GND															GND	DLD1N	DLD1	DHD0N	DHD0
К	AHD1	AHD1N	ALD2	ALD2N	VCC															VCC	DLD2N	DLD2	DHD1N	DHD1
J	AHD2	AHD2N	ALD3	ALD3N	GND															GND	DLD3N	DLD3	DHD2N	DHD2
Н	AHD3	AHD3N	ALD4	ALD4N	VCCO															VCCO	DLD4N	DLD4	DHD3N	DHD3
G	AHD4	AHD4N	ALD5	ALD5N	GND															GND	DLD5N	DLD5	DHD4N	DHD4
F	AHD5	AHD5N	vcco	GND	GND						1									GND	GND	vcco	DHD5N	DHD5
E	AHD6	AHD6N	VCCO	GND	GND	VCCO	VCC	GND	GND	GND	GND	GND	GND	GND	GND	GND	GND	VCC	VCCO	GND	GND	VCCO	DHD6N	DHD6
D	AHD7	AHD7N	VCC	GND	VCCO	VCC	VCC	GND	GND	GND	GND	GND	GND	GND	GND	GND	GND	VCC	VCC	VCCO	GND	VCC	DHD7N	DHD7
С	AHOR	AHORN	VCC	GND	VCC	VCC	GND	GND	GND	GND	GND	GND	GND	GND	GND	GND	GND	GND	VCC	VCC	GND	VCC	DHORN	DHOR
В	GND	VCC	ALD6N	ALD7N	ALORN	GND	GND	GND	GND	GND	GND	CMIRef	CMIRef	GND	GND	GND	GND	GND	GND	DLORN	DLD7N	DLD6N	VCC	GND
A	GND	VCC	ALD6	ALD7	ALOR	GND	AAI	AAIN	GND	BAI	BAIN	GND	GND	CAI	CAIN	GND	DAI	DAIN	GND	DLOR	DLD7	DLD6	VCC	GND
	1 2 3 4 5 6 7 8 9 10 11 12 13 14 15 16 17 18 19 20 21 22 23 24 VCC=3.3V VCCO = 1.8V VCCD = 1.8V																							

6.2 Pinout Table

Table 6-1.Pinout Table

Pin Label	Pin Number	Description		
Power Supplies	•			
GND	A1, A6, A9, A12, A13, A16, A19 A24, B1, B6, B7, B8, B9, B10, B11, B14, B15, B16, B17, B18, B19, B24, C4, C7, C8, C9, C10, C11, C12, C13, C14, C15, C16, C17, C18, C21, D4, D8, D9, D10, D11, D12, D13, D14, D15, D16, D17, D21, E8, E9, E10, E11, E12, E13, E14, E15, E16, E17, J5, J20, L5, L20, P5, P20, T5, T20, Y8, Y9, Y12, Y13, Y16, Y17, AA4, AA8, AA9, AA12, AA13, AA16, AA17, AA21, AB4, AB6, AB8, AB9, AB12, AB13, AB16, AB17, AB19, AB21, AC1, AC6, AC12, AC13, AC19, AC24, AD1, AD6, AD19, AD24, E4, E5, E20, E21, F4, F5, F20, F21, G5, G20, V5, V20, W4, W5, W20, W21, Y4, Y5, Y20, Y21	Ground		
V _{cc}	A2, A23, B2, B23, C3, C5, C6, C19, C20, C22, D3, D6, D7, D18, D19, D22, E7, E18, K5, K20, M5, M20, N5, N20, R5, R20, Y7, Y10, Y15, Y18, AA3, AA6, AA7, AA10, AA15, AA18, AA19, AA22, AB3, AB5, AB7, AB10, AB15, AB18, AB20, AB22, AC2, AC23, AD2, AD23, AA14, AB14, Y14	Analog + SPI pads power supply (3.3V)		
V _{CCD}	Y11, AB11, AA11	Digital power supply (1.8V)		
V _{cco}	D5, D20, E3, E6, E19, E22, F3, F22, H5, H20, U5, U20, W3, W22, Y3, Y6, Y19, Y22, AA5, AA20	Output power supply (1.8V)		
Clock Signal				
CLK	AD12	In-phase input clock signal		
CLKN	AD13	Out-of-phase input clock signal		
Analog Input Signals				
AAI	A7	In-phase analog input channel A		
AAIN	A8	Out-of phase analog input channel A		
BAI	A10	In-phase analog input channel B		
BAIN	A11	Out-of phase analog input channel B		
CAI	A14	In-phase analog input channel C		
CAIN	A15	Out-of-phase analog input channel C		
DAI	A17	In-phase analog input channel D		
DAIN	A18	Out-of-phase analog input channel D		

Table 6-1. Pinout Table (Continued)

Pin Label	Pin Number Description				
Digital Output Signals					
ALD0	МЗ				
ALD1	L3				
ALD2	КЗ				
ALD3	J3				
ALD4	НЗ	Channel A port L In-phase output data			
ALD5	G3				
ALD6	A3				
ALD7	A4				
ALDON	M4				
ALD1N	L4				
ALD2N	К4				
ALD3N	J4				
ALD4N	H4	Channel A port L out-of-phase output data			
ALD5N	G4				
ALD6N	B3				
ALD7N	B4				
ALOR	A5				
ALORN	B5	Channel A port L out-of-range bit			
AHD0	L1				
AHD1	К1				
AHD2	J1				
AHD3	H1	Channel A port H in-phase output data			
AHD4	G1				
AHD5	F1				
AHD6	E1				
AHD7	D1				
AHDON	L2				
AHD1N	К2				
AHD2N	J2				
AHD3N	H2	Channel A port H out-of-phase output data			
AHD4N	G2				
AHD5N	F2				
AHD6N	E2				
AHD7N	D2				
AHOR	C1	Channel A port H out-of-range bit			
AHORN	C2				
ADR	M1	Channel A cutnut clock			
ADRN	M2				

Pin Label	Pin Number	Description				
BLD0	N3					
BLD1	P3					
BLD2	R3	Channel Dinest Lingshees subject date				
BLD3	ТЗ					
BLD4	U3	Channel B port L in phase output data				
BLD5	V3					
BLD6	AD3					
BLD7	AD4					
BLDON	N4					
BLD1N	P4					
BLD2N	R4					
BLD3N	Τ4					
BLD4N	U4	Channel B port L out-of-phase output data				
BLD5N	V4					
BLD6N	AC3					
BLD7N	AC4					
BLOR	AD5					
BLORN	AC5	Channel B port L out-of-range bit				
BHD0	P1					
BHD1	R1					
BHD2	T1					
BHD3	U1	Channel R part H in phase output data				
BHD4	V1	Charmer B port i i in priase output data				
BHD5	W1					
BHD6	Y1					
BHD7	AA1					
BHD0N	P2					
BHD1N	R2					
BHD2N	T2					
BHD3N	U2	Channel R next H out of phase output data				
BHD4N	V2	Channel B port H out-of-phase output data				
BHD5N	W2					
BHD6N	Y2					
BHD7N	AA2					
BHOR	AB1	Channel B part H out of range hit				
BHORN	AB2	Channel B port H out-oi-range bit				
BDR	N1	Channel B output clock				
BDRN	N2					

 Table 6-1.
 Pinout Table (Continued)

 Table 6-1.
 Pinout Table (Continued)

Pin Label	Pin Number	Description				
CLD0	N22					
CLD1	P22					
CLD2	R22					
CLD3	T22					
CLD4	U22	Channel C port L in phase output data				
CLD5	V22					
CLD6	AD22					
CLD7	AD21					
CLDON	N21					
CLD1N	P21					
CLD2N	R21					
CLD3N	T21	Chappel C port L out of phase output data				
CLD4N	U21	Channel C port L out of phase output data				
CLD5N	V21					
CLD6N	AC22					
CLD7N	AC21					
CLOR	AD20	Channel C next L out of renge hit				
CLORN	AC20					
CHD0	P24					
CHD1	R24					
CHD2	T24					
CHD3	U24	Channel C part H in phase output data				
CHD4	V24	Channel C port H in phase output data				
CHD5	W24					
CHD6	Y24					
CHD7	AA24					
CHD0N	P23					
CHD1N	R23					
CHD2N	T23					
CHD3N	U23	Chappel C port H out of phase output data				
CHD4N	V23	Channel C port i i out of phase output data				
CHD5N	W23					
CHD6N	Y23					
CHD7N	AA23					
CHOR	AB24	Channel C part H out of range hit				
CHORN	AB23					
CDR	N24	Channel C Output clock				
CDRN	N23					

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Table 6-1.	Pinout Table	(Continued)
Table 6-1.	Pinout Table	(Continuea)

Pin Label	Pin Number	Description
DLD0	M22	
DLD1	L22	
DLD2	K22	
DLD3	J22	Channel D next L in phase subout data
DLD4	H22	Channel D port L in-phase output data
DLD5	G22	
DLD6	A22	
DLD7	A21	
DLDON	M21	
DLD1N	L21	
DLD2N	K21	
DLD3N	J21	Channel D port L out-of-phase output data
DLD4N	H21	
DLD5N	G21	
DLD6N	B22	
DLD7N	B21	
DLOR	A20	Channel D port L out-of-range hit
DLORN	B20	
DHD0	L24	
DHD1	K24	
DHD2	J24	
DHD3	H24	Channel D port H in-phase output data
DHD4	G24	
DHD5	F24	
DHD6	E24	
DHD7	D24	
DHDON	L23	
DHD1N	K23	
DHD2N	J23	
DHD3N	H23	Channel D port H out-of-phase output data
DHD4N	G23	
DHD5N	F23	
	E23	
	023	
DHOR	C24	Channel D port H out-of- range bit
DHORN	C23	
DDR	M24	Channel D Output clock
	M23	
SPI Signals		
Csn	AC16	Chip select (Active low)
Sclk	AD16	SPI clock
MOSI	AD17	Master out, Slave In SPI input
MISO	AC17	Master In, Slave Out SPI output

Table 6-1. Pinout Table (Continued)

Pin Label	Pin Number	Description
Other Signals		
rstn	AC15	SPI asynchronous reset (active low)
scan0 scan1 scan2	AD14 AC14 AD15	Scan mode signals Pull up to V_{CC} with 4.7 $K\Omega$
SYNCN SYNCP	AC11 AD11	Synchronization signal
Res50 Res62	AD18 AC18	50 Ω and 62 Ω reference resistor input
CMIRefAB CMIRefCD	B12 B13	Output reference for channel A-B and C-D Input common mode
DiodA DiodC	AD7 AC7	Temperature diode Anode and Cathode
trigp trign tdcop tdcon	AD10 AC10 AD9 AC9	Reserved pins See "Test Signals" on page 49. for more information
tdreadyn	AC8	Connect to ground
tdreadyp	AD8	Connect to ground

7. Characterization Results

Nominal conditions (unless otherwise specified):

- $V_{CC} = 3.3V$, $V_{CCD} = 1.8V$, $V_{CCO} = 1.8V$
- -1 dBFS analog input (Full scale Input: $V_{IN} V_{INN} = 500 \text{ mVpp}$)
- Clock input differentially driven; analog-input differentially driven
- Default mode: four-channel mode ON, binary output data format, Digital interface ON, 1:2 DMUX ON, Standby mode OFF, minimum bandwidth







Figure 7-2. Crosstalk (Fc = 2.5 GHz, Channel A on Channel B)

Figure 7-3. Crosstalk (Fc = 2.5 GHz, Channel B on Channel C)



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Figure 7-4. Step Response (Fc = 2.5 GHz, DMUX 1:2 Mode, Fin = 300 MHz)

Figure 7-5. ENOB versus Input Frequency (Fc = 2.5 GHz)





Figure 7-6. SNR versus Input Frequency (Fc = 2.5 GHz)

Figure 7-7. THD versus Input Frequency (Fc = 2.5 GHz)



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Figure 7-8. SFDR versus Input Frequency (Fc = 2.5 GHz)

Figure 7-9. ENOB versus Sampling Frequency (Fin = 620 MHz)





Figure 7-10. SNR versus Sampling Frequency (Fin = 620 MHz)

Figure 7-11. THD versus Sampling Frequency (Fin = 620 MHz)



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Figure 7-12. SFDR versus Sampling Frequency (Fin = 620 MHz)







Figure 7-14. SNR versus Power Supplies (Fc = 2.5 GHz, Fin = 100 MHz)







Figure 7-16. SFDR versus Power Supplies (Fc = 2.5 GHz, Fin = 100 MHz)

Figure 7-17. ENOB versus Temperature (Fc = 2.5 GHz, Fin = 100 MHz)





Figure 7-18. SNR versus Temperature (Fc = 2.5 GHz, Fin = 100 MHz)

Figure 7-19. THD versus Temperature (Fc = 2.5 GHz, Fin = 100 MHz)



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Figure 7-20. SFDR versus Temperature (Fc = 2.5 GHz, Fin = 100 MHz)







Figure 7-22. Dual Tone Signal Spectrum (Fc = 2.5 GHz, Fin1 = 490 MHz, Fin2 = 495 MHz) in Fourchannel Mode





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8. Functional Description



Figure 8-1. Quad ADC Functional Diagram

Table 8-1.Functions Description

Name	Function	Name	Function
V _{CCA}	3.3V Analog power supply	CLOR, CLORN	Channel C port L Differential out-of-range
V _{CCD}	1.8V Digital power supply	CHOR, CHORN	Channel C port H Differential out-of-range
V _{cco}	1.8V Output power Supply	DLOR, DLORN	Channel D port L Differential out-of-range
GND	Ground	DHOR, DHORN	Channel D port H Differential out-of-range
AAI, AAIN	Channel A Differential analog Input	ADR, A DRN	Channel A Differential data ready
BAI, BAIN	Channel B Differential analog Input	BDR, BDRN	Channel B Differential data ready
CAI, CAIN	Channel C Differential analog input	CDR, CDRN	Channel C Differential data ready
DAI, DAIN	Channel D Differential analog Input	DDR, DDRN	Channel D Differential data ready
CLK,CLKN	Differential clock input	SYNC, SYNCN	Synchronization of data ready (LVDS)

Name	Function	Name	Function
[ALD0:ALD7][ALD0N:ALD7N]	Channel A port L Differential output data	SCLK	SPI Clock
[AHD0:AHD7][AHD0N:AHD7N]	Channel A port H Differential output data	MISO	Master In Slave Out SPI output
[BLD0:BLD7][BLD0N:BLD7N]	Channel B port L Differential output data	MOSI	Master Out Slave In SPI Input
[BHD0:BHD7] [BHD0N:BHD7N]	Channel B port H Differential output data	CSN	Chip select (active Low)
[CLD0:CLD7] [CLD0N:CLD7N]	Channel C port L Differential output data	RSTN	SPI asynchronous reset (active low)
[CHD0:CHD7][CHD0N:CHD7N]	Channel C port H Differential output data	SCAN<2:0>	Digital scan mode signal - for e2v use only
[DLD0:DLD7][DLD0N:DLD7N]	Channel D port L Differential output data	DIODEA	Diode Anode for die junction temperature monitoring
[DHD0:DHD7][DHD0N:DHD7N]	Channel D port H Differential output data	DIODEC	Diode Cathode for die junction temperature monitoring
ALOR, ALORN	Channel A port L Differential out-of-range	Tdreadyp, Tdreadyn, Trigp, Trign, Tdcop, Tdcon	Reserved pins
AHOR, AHORN	Channel A port H Differential out-of-range	Res50, Res62	50Ω and 62Ω reference resistor inputs
BLOR, BLORN	Channel B port L Differential out-of-range	CMIRefAB, CMIRefCD	Output reference for Input common mode channels A and B and channels C and D
BHOR, BHORN	Channel B port H Differential out-of-range		

Table 8-1. Functions Description (Continued)

8.1 ADC Synchronization Signal (SYNC, SYNCN)

The SYNC, SYNCN signal has LVDS electrical characteristics. It is active high and should last at least 2 clock cycles to work properly.

Once asserted, it has an effect on the output clock signals which are then forced to LVDS low level as described in Figure 8.2. During reset, the output data are not refreshed.

Once de-asserted, the output clock signals restart toggling after (TDR + pipeline delay) + Y clock cycles, where Y can be selected via the Serial Peripheral Interface at address 0x06 (from 0 to 15). This SYNC signal can be used to ensure the synchronization of multiple ADCs.

The SYNCN, SYNCP signal is mandatory whenever the following ADC modes are changed: Standby, DMUX mode, Test mode (see note ⁽³⁾), channel mode. For all other ADC modes there is no need to perform a SYNCN, SYNCP.

Examples:

The SYNCN, SYNCP signal is mandatory after power up or power configuration: when switching the ADC from standby (full or partial) to normal mode.

The SYNCN, SYNCP signal is mandatory after channel mode configuration: when switching the ADC from 4-channel mode to 1-channel mode.

The SYNCN, SYNCP signal is mandatory after test sequence: when switching the ADC from normal running mode to ramp or flashing mode but it is no needed when the ADC is switched from test mode (ramp or flashing) to normal running mode.

Notes: 1. In DMUX 1:2 mode, the SYNC, SYNCN signal also resets the clock divider for the DMUX.

- 2. In decimation mode, the SYNC, SYNCN signal also resets the clock dividers for decimation, therefore data outputs are not refreshed or may be corrupted when SYNC, SYNCN is active.
- 3. Refer to Figure 8-2.





- Notes: 1. X refers to A, B, C and D. This timing has been built with no extra clock cycles (SPI address 0x06 label: SYNC, value = 0).
 - The first edges of output data Ready signal capture an old data (data held before SYNC time), the valid data (data N) arrives after pipeline delay (the number of invalid clock edges depend on ADC configuration).

Figure 8-3. ADC Timing in 4-Channel Mode, 1:2 DMUX Mode (For Each Channel)

Notes: 1. X refers to A, B, C and D.

This timing has been built with no extra clock cycles (SPI address 0x06 label: SYNC, value = 0).

 The first edges of output data Ready signal capture an old data (data held before SYNC time), the valid data (data N) arrives after pipeline delay (the number of invalid clock edges depend on ADC configuration). The extra clock configuration allows to delay the restart of output data and data ready after SYNC. With this extra clock delay, the validity range of SYNC signal is extended.

Figure 8-4. Output Data and Data Ready with Extra Delay Configuration

Note: X refers to A, B, C and D. Y refers to the number of extra clock that can be added (Y = 0 to 15) with programming delay of ADC data ready after SYNC See Section 8.7 "Quad ADC Digital Interface (SPI)" on page 50, (register address 0x06).

8.2 Digital Reset (RSTN)

This is a global reset for the SPI register. It is active low. There are two ways to reset the Quad 8-bit 1.25 Gsps ADC:

- By asserting low the RSTN primary pad (hardware reset)
- By writing a "1" in the bit SWRESET of the SWRESET register through the SPI (software reset)

Both ways will clear all configuration registers to their reset values.

The RSTN is an asynchronous reset which acts on the SPI. If the RSTN is applied during an access (write or read) to the SPI, this access will be lost and default values will be written in the registers. The RSTN pulse should last at least 10 ns. This RSTN should be applied at power up of the chip (recommended before the clocks are applied).

8.3 Digital Scan Mode (SCAN[2:0])

These signals allow to perform a scan of the digital part of the ADC.

- For e2v use only
- Pull up to V_{CC} with 4.7 $K\!\Omega$

8.4 Die Junction Temperature Monitoring Diode

DIODEA, DIODEC: two pins are provided so that the diode can be probed using standard temperature sensors from the market.

It is recommended to protect the diode using 2×3 head-to-tail diodes as illustrated in Figure 8-5 (note that if a standard temperature sensor is used, the protection diodes are not necessary).

Figure 8-5. Protection Diodes for the Junction Temperature Monitoring Diode

DIODC (AC7)

Figure 8-6. Diode Characteristics (I = 1 mA)

8.5 Test Signals

The reserved signals (trigp pin AD10, trign pin AC10, tdreadyp pin AD8, tdreadyn pin AC8, tdcop pin AD9 and tdcon pin AC9) should be connected as described in Figure 8-7.

Figure 8-7. Reserved Pins Recommended Implementation

8.6 Res50 and Res62

The Res50 and Res62 correspond to the input of internal 50Ω and 62Ω reference resistors that are used to check the process deviation. The idea is to inject a current into pin Res50, measure the voltage across Res50 and nearest ground pin (AD19), the same process should be used for Res62. You then have two equations with two unknown parameters:

- Res50 = k × 50 + e1
- Res62 = k × 62 + e2
 - where k is due to the process
 - where e1 and e2 are due to the measurement errors

Assuming that $e_1 = e_2$ since the same process is used to measure both Res50 and Res62 in the same conditions, you can obtain the k factor by working out this equation, which helps you determine if you need to compensate for the process by increasing or decreasing the resistors value (TRIMMER register at address 0x13) of the input resistors (there are two 50 Ω resistors per analog input channel).

8.7 Quad ADC Digital Interface (SPI)

The digital interface is a standard SPI (3.3V CMOS) with:

- 8 bits for the address A[7] to A[0] including a R/W bit (A[7] = R/W and is the MSB)
- 16 bits of data D[15] to D[0] with D[15] the MSB

Five signals are required:

- SCLK for the SPI clock
- CSN for the Chip Select
- MISO for the Master In Slave Our SPI Output
- MOSI for the Master Out Slave In SPI Input
- RSTN for SPI RESET

The MOSI sequence should start with one R/W bit:

- R/W = 0 is a read procedure
- R/W = 1 is a write procedure (refer to timing diagram in Section 8.8.1)

8.7.1 Registers Description

Table 8-2.Registers Mapping

Address	Label	Description	R/W	Default Setting
Common Regis	ters			
0x00	Chip ID	Chip ID and version	Read only	0x0119
0x01	Control Register	ADC mode (channel mode) Standby DMUX Binary/Gray Test mode ON/OFF Bandwidth selection Full scale selection	R/W	four-channel mode (1.25 Gsps) No standby DMUX 1:2 Binary coding Test mode OFF Min bandwidth 500 mVpp full scale
0x02	STATUS	Status register	Read only	

Address	Label	Description	R/W	Default Setting
0x04	SWRESET	Software SPI reset	R/W	No reset
0x05	TEST	Test Mode	R/W	Test pattern = ramp
0x06	SYNC	Programmable delay on ADC data ready after Reset SYNC, SYNCN (4 bits)	R/W	0 extra clock cycle
0x0F	Channel Select	Channel X Selection	R/W	0x0000
Per Channel Re	gisters (X=A/B/C/D)			
0x10	Cal Ctrl X	Calibration control register of Channel X	R/W	
0x11	Cal Ctrl X Mlbx	Status/Busy of current Calibration of channel X	Read only (poll)	
0x12	Status X	Global status of channel X	Read only	
0x13	Trimmer X	Impedance Trimmer of channel X	R/W	0x08
0x20	Ext Offset X	External offset Adjustment of channel X	R/W	0 LSB
0x21	Offset X	Offset adjustment of channel X	Read only	0 LSB
0x22	Ext Gain X	External Gain Adjustment of channel X	R/W	0 dB
0x23	Gain X	Gain adjustment of channel X	Read only	0 dB
0x24	Ext Phase X	External phase Adjustment of channel X	R/W	0 ps
0x25	Phase X	Phase adjustment of channel X	Read only	0 ps
0x30 to 0x32	Ext INL1 X	External first level INL Adjustment of channel X (3x16bits)	R/W	0x0000 (no INL correction)
0x33 to 0x35	Ext INL2 X	External second level INL Adjustment of channel X (3x16bits)	R/W	0x0000 (no INL correction)
0x36 to 0x38	INL1 X	1st level INL Adjustment of Channel X (3x16bits)	Read Only	0x0000
0x39 to 0x3B	INL2 X	2nd level INL Adjustment of Channel X (3x16bits)	Read Only	0x0000

Table 8-2. Registers Mapping (Continued)

Notes: 1. All registers are 16 bits long.

2. The *external* gain/offset/phase adjustment registers correspond to the registers where one can write the external values to calibrate the gain/offset/phase parameters of the ADCs. The Gain/offset/phase adjustment registers are read only registers. They provide you with the internal settings for the gain/offset/phase parameters. The *external* and read only adjustment registers should give the same results two by two once any calibration has been performed.

8.7.2 Chip ID Register (Read Only)

Table 8-3. Chip ID Register Mapping: Address 0x00

Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
			TY	PE					BRANC	CH<3:0>		MAJVE	RS<1:0	MINVE ;	:RS<1:0 >

Table 8-4. Chip ID Register Description

Bit label	Value	Description	Default Setting
MINVERS <1:0>		Minor version number	00
MAJVERS<1:0>		Major version number	10
BRANCH<3:0>		Branch number	0001
TYPE<7:0>		Chip type	0000001

8.7.3 Control Register

Table 8-5. Control Register Mapping: Address 0x01

Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
UNU	ISED	RESER VED	TEST	RESER VED	FS	BDW	<1:0>	B/G	DMU X	STDBY	(<1:0>	A		DE <3:0	>

Bit label	Value	Description	Default Setting	
	00XX	Four-channels mode (1.25 Gsps per channel)		
	0100	Two-channel mode (channel A and channel C, 2.5 Gsps per channel)		
	0101	Two-channel mode (channel B and channel C, 2.5 Gsps per channel)		
	0110	Two-channel mode (channel A and channel D, 2.5 Gsps per channel)		
	0111	Two-channel mode (channel B and channel D, 2.5 Gsps per channel)		
	1000	One-channel mode (channel A, 5 Gsps)		
ADCMODE <3:0>	1001	One-channel mode (channel B, 5 Gsps)	0000 Four-channels Mode	
	1010	One-channel mode (channel C, 5 Gsps)		
	1011	One-channel mode (channel D, 5 Gsps)		
	1100	Common input mode, simultaneous sampling (channel A)		
	1101	Common input mode, simultaneous sampling (channel B)		
	1110	Common input mode, simultaneous sampling (channel C)		
	1111	Common input mode, simultaneous sampling (channel D)		
	00	Full Active Mode		
STDDV 410	01	Standby channel A/channel B: If four-channel mode selected then standby of channel A and B If two-channel mode selected, standby of channel A or B If one-channel mode selected then full standby	00 - Full Active Mode	
51061 <1.0>	10	Standby channel C/channel D if four-channel mode selected then standby of channel C and D if two-channels mode selected, standby of channel C or D if one-channel mode selected then full standby		
	11	Full standby		
DMUX	0	1:2 DMUX	0	
DIVIOX	1	1:1 DMUX	1:2 DMUX	
D/O	0	Binary	0	
B/G	1	Gray	Binary coding	
	00	Minimum bandwidth (500 MHz typical)		
	01	Reduced bandwidth (600 MHz typical)	00	
BDW <1:0>	10	Nominal bandwidth (1.5 GHz typical)	Min bandwidth	
	11	Full bandwidth (2 GHz typical)		
FS	0	500 mVpp Full scale	0	
	1	625 mVpp full scale	SOU mypp full scale	
TEOT	0	No test mode	0	
1651	1	Test mode activated, refer to the test register	No Test Mode	

Table 8-6. Control Register Description

Description	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Label	B/G	DMUX	STDB	/ <1:0 >		ADCMO	DE <3:0>	
Four-channel mode 1.25 Gsps max. per channel	x	x	x	x	0	0	x	x
Two-channel mode (channel A and channel C)2.5 Gsps max. per channel	x	x	x	x	0	1	0	0
Two-channel mode (channel B and channel C)2.5 Gsps max. per channel	x	x	x	x	0	1	0	1
Two-channel mode (channel A and channel D)2.5 Gsps max. per channel	x	x	x	x	0	1	1	0
Two-channel mode (channel B and channel D)2.5 Gsps max. per channel	x	x	x	x	0	1	1	1
One-channel mode (channel A, 5 Gsps max)	х	х	х	х	1	0	0	0
One-channel mode (channel B, 5 Gsps)	х	х	х	х	1	0	0	1
One-channel mode (channel C, 5 Gsps)	х	х	х	х	1	0	1	0
One-channel mode (channel D, 5 Gsps)	х	х	х	х	1	0	1	1
Simultaneous sampling (channel A) ^(Note:)	х	х	х	х	1	1	0	0
Simultaneous sampling (channel B) ^(Note:)	х	х	х	х	1	1	0	1
Simultaneous sampling (channel C) ^(Note:)	х	х	х	х	1	1	1	0
Simultaneous sampling (channel D) ^(Note:)	Х	Х	Х	х	1	1	1	1
No standby (except if ADCMODE = 11XX)	Х	Х	0	0	х	Х	х	х
Standby channel A, channel B	х	х	0	1	х	х	х	х
Standby channel C, channel D	х	х	1	0	х	х	х	х
Full Standby	х	х	1	1	х	х	х	х
1:2 DMUX mode	х	0	Х	х	х	х	х	х
1:1 DMUX mode	х	1	Х	х	х	х	х	х
Binary coding	0	х	Х	х	х	х	х	х
Gray coding	1	х	х	х	х	х	х	х

Table 8-7. Control Register Settings (Address 0x01): Bit7 to Bit0

Note: When bit3 bit2 = 11, the external clock signal and analog input signal are applied internally to the four ADC cores. The value of bit1 bit0 gives the channel on which the analog input should be applied.

Description	Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8
Label	Unused	Unused	Reserved	TEST	Reserved	FS	BDW	<1:0>
Min. bandwidth	х	х	0	х	0	х	0	0
Reduced bandwidth	х	х	0	х	0	х	0	1
Nominal bandwidth	Х	Х	0	х	0	Х	1	0
Full bandwidth	Х	Х	0	х	0	Х	1	1
500 mVpp full scale	х	Х	0	х	0	0	х	х
625 mVpp full scale	Х	Х	0	х	0	1	Х	Х
Test mode OFF	Х	Х	0	0	0	Х	Х	Х
Test mode ON	Х	Х	0	1	0	Х	Х	Х

Table 8-8. Control Register Settings (Address 0x00): Bit15 to Bit8

Table 8-9.ADCMODE and STBY Allowed Combinations

Description	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Label	B/G	DMUX	STDB	/ <1:0>		ADCMOD)E <3:0>	
Four-channel mode, 1.25 Gsps max No standby	x	x	0	0	0	0	x	x
Four-channel mode,1.25 Gsps max Standby channel A, channel B	x	x	0	1	0	0	х	x
Four-channel mode, 1.25 Gsps max Standby channel C, channel D	x	x	1	0	0	0	x	x
Four-channel mode (1.25 Gsps max) Full Standby	x	x	1	1	0	0	x	x
Two-channel mode, 2.5 Gsps max (Channels A and C) No Standby	x	x	0	0	0	1	0	0
Two-channels mode, 2.5 Gsps max (Channels A and C) Standby channel A	x	x	0	1	0	1	0	0
Two-channel mode, 2.5 Gsps max (Channels A and C) Standby Channel C	x	x	1	0	0	1	0	0
Two-channel mode, 2.5 Gsps max (Channels A and C) Full Standby	x	x	1	1	0	1	0	0
Two-channel mode, 2.5 Gsps max (Channels B and C) No Standby	x	x	0	0	0	1	0	1
Two-channel mode, 2.5 Gsps max (Channels B and C) Standby Channel B	x	x	0	1	0	1	0	1
Two-channel mode, 2.5 Gsps max (Channels B and C) Standby Channel C	x	x	1	0	0	1	0	1
Two-channel mode, 2.5 Gsps max (Channels B and C) Full Standby	x	x	1	1	0	1	0	1
Two-channel mode, 2.5 Gsps max (Channel A and D) No Standby	x	x	0	0	0	1	1	0

Description	Bit 7	Bit 6	Bit 5 Bit 4		Bit 3	Bit 2	Bit 1	Bit 0
Label	B/G	DMUX	STDB	(<1:0>		ADCMOE)E <3:0>	1
Two-channel mode, 2.5 Gsps max (Channels A and D) Standby Channel A	x	x	0	1	0	1	1	0
Two-channel mode, 2.5 Gsps max (Channels A and D) Standby Channel D	x	x	1	0	0	1	1	0
Two-channel mode, 2.5 Gsps max (Channels A and D) Full standby	x	x	1	1	0	1	1	0
Two-channel mode, 2.5 Gsps max (Channels B and D) No standby	x	x	0	0	0	1	1	1
Two-channel mode, 2.5 Gsps max (Channels B and D) Standby channel B	x	x	0	1	0	1	1	1
Two-channel mode, 2.5 Gsps max (channels B and D) Standby channel D	x	x	1	0	0	1	1	1
Two-channel mode, 2.5 Gsps max (channels B and D) Full standby	x	x	1	1	0	1	1	1
One-channel mode (channel A, 5 Gsps max) No standby	x	x	0	0	1	0	0	0
One-channel mode (channel B, 5 Gsps max) No standby	x	x	0	0	1	0	0	1
One-channel mode (channel C, 5 Gsps max) No standby	x	x	0	0	1	0	1	0
One-channel mode (channel D, 5 Gsps) No standby	x	x	0	0	1	0	1	1
One-channel mode (channel A, 5 Gsps) Full standby	x	x	01 or 1	0 or 11	1	0	0	0
One-channel mode (channel B, 5 Gsps) Full standby	x	x	01 or 1	0 or 11	1	0	0	1
One-channel mode (Channel C, 5 Gsps) Full standby	x	x	01 or 1	0 or 11	1	0	1	0
One-channel mode (Channel D, 5 Gsps) Full standby	x	x	01 or 1	0 or 11	1	0	1	1
Common input mode (Channel A, 1.25 Gsps) No standby	x	x	0	0	1	1	0	0
Common input mode (Channel B, 1.25 Gsps) No standby	x	x	0	0	1	1	0	1
Common input mode (Channel C, 1.25 Gsps) No standby	x	x	0	0	1	1	1	0
Common input mode (Channel D, 1.25 Gsps) No standby	x	x	0	0	1	1	1	1
Common input mode (Channel A, 1.25 Gsps) Full standby	x	x	01 or 1	0 or 11	1	1	0	0

Table 8-9. ADCMODE and STBY Allowed Combinations (Continued)

Table 8-9. ADCMODE and STBY Allowed Combinations (Continued)

Description	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	
Label	B/G	DMUX	STDBY	/ <1:0>	ADCMODE <3:0>				
Common input mode (Channel B, 1.25 Gsps) Full standby	X X 01 or 10 or 11				1	1	0	1	
Common input mode (Channel C, 1.25 Gsps) Full standby	X X 01 or 10 or 11				1	1	1	0	
Common input mode (Channel D, 1.25 Gsps) Full standby	x	x	01 or 1	0 or 11	1	1	1	1	

8.7.4 STATUS Register (Read Only)

Table 8-10. Status Register Mapping: Address 0x02

Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
					Unus	ed							ADCXU	JP<3:0>	

Table 8-11. STATUS Register Description

Bit label	Value	Description	Default Setting
	XXX0	ADC A standby	
	XXX1	ADC A active	
	XX0X	ADC B standby	*
	XX1X	ADC B active	
ADUXUP<3:0>	X0XX	ADC C standby	
	X1XX	ADC C active	*
	0XXX	ADC D standby	
	1XXX	ADC D active	

8.7.5 SWRESET Register

Table 8-12. SWRESET Register Mapping: Address 0x04

Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
					Unus	ed							SWR	ESET	

Table 8-13. SWRESET Register Description

Bit label	Value	Description	Default Setting
	0	No Software Reset	0
SWRESET	1	Unconditional Software Reset, see ^(Note:)	No software reset

Note: Global software reset will reset *all* design registers (configuration registers as well as any flip-flop in the digital part of the design). This bit is automatically reset to 0 after some ns. There is no need to clear it by an external access.

8.7.6 TEST Register

 Table 8-14.
 TEST Register Mapping: Address 0x05

Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
					ι	Jnused							RESE	RVED	TEST M

Notes: 1. TESTM is taken into account only if bit12 (TEST) of Control register (address 0x01) is at 1.

2. It is mandatory to apply a SYNC, SYNCN signal to the ADC whenever the test mode is activated or deactivated. There is no need to perform a SYNCP, SYNCN when the ADC returns to normal running mode.

Table 8-15.

Bit label	Value	Description	Default Setting
	0	Increasing simultaneous ramp	0
TESTM	1	Flashing 1 (1 FF pattern every ten 00 patterns) on each ADC	Increasing ramp

8.7.7 SYNC Register

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Table 8-16.	SYNC Register	Description
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Bit label	Value	Description	Default Setting
	0000	0 extra clock cycle before starting up	
	0001	00000	
SYNC<3:0>			Clock cycle
	1111	15 extra clock cycles before starting up	*

8.7.8 CHANNEL SELECTOR Register

Table 8-17. CHANNEL SELECTOR Register Mapping: Address 0x0F	
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Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
					L	Jnused							Chanr	nel Select	or <2:0>

Table 8-18. CHANNEL SELECTOR Register Description

Bit label	Value	Description	Default Setting
	000	No channel selected (only common registers are accessible)	
	001	Channel A selected to access to "per-channel" registers	
Channel Calestor (200)	010	000	
Channel Selector <2.0>	011	No channel selected	
	100	Channel D selected to access to "per-channel" registers	
	Any others	No channel selected (only common registers are accessible)	

Note: The CHANNEL SELECTOR register should be set before any access to *per-channel* registers in order to determine which channel is targeted.

8.7.9 CAL Control Registers

Applies to CAL Control registers A, B, C and D according to CHANNEL SELECTOR register contents.

Table 8-19. CAL Control Register Mapping: Address 0x10

Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Unused						PCALC	CTRL X	GCAL	.CTRL	OCAL	.CTRL	INLCA	LCTRL X		
						<1	:0>	X <	1:0>	X <	1:0>	<	1:0>		

Table 8-20. CAL Control Register Description

Bit label	Value	Description	Default Setting
	00	Idle mode (no external INL tuning requested) for selected channel	
	01	00	
INLCALCTRL X <1:0>	10		
	11		
	00	Idle mode for selected channel	
	01	Idle mode for selected channel	
<1:0>	10	External offset adjust for selected channel (transfer of Ext Offset register content into current Offset register)	00
	11	Idle mode for selected channel	

Bit label	Value	Description	Default Setting		
	00	Idle mode for selected channel			
	01	Idle mode for selected channel			
<1:0>	10	External gain adjust for selected channel (transfer of Ext Gain register content into current Gain register)	00		
	11	Idle mode for selected channel	Ť		
	00	Idle mode for selected channel	l		
	01	Ť			
<1:0>	10	External phase adjust for selected channel (transfer of Ext Phase register content into current Phase register)	00		
	11	Idle mode for selected channel	Ť		

Table 8-20.	CAL Control Register Description ((Continued)	ļ
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Notes: 1. Writing to the register will starts the corresponding operation(s). In that case, the Status/Busy bit of the mailbox (see below) is asserted until the operation is over. (At the end of a calibration/tuning process, CAL Control register relevant bit slice is NOT reset to default value.)

- 2. If different calibrations are ordered, they are performed successively following the priority order defined hereafter:
 - -INL has priority over any other
 - -Gain has priority over Offset, and Phase
 - -Offset has priority over Phase

The transfer function of the ADC is given by the following formula transfer function result = offset + (input \times gain).

8.7.10 CAL Control Registers Mailbox (Read Only)

Applies to CAL Control Registers Mailbox A, B, C and D according to CHANNEL SELECTOR register contents.

Table 8-21.

Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
						Ur	nused								STATUS/B USY X

Table 8-22. CAL Control Registers Mailbox Description

Bit label	t label Value Description					
STATUS/BUSY X	0	Selected channel is ready (to receive new calibration orders)	0			
	1	Selected channel is busy				

Note: When selected channel is busy, it will not be able to deal any new calibration orders coming from SPI.

8.7.11 GLOBAL STATUS Register (Read Only)

Applies to GLOBAL STATUS registers A, B, C and D according to CHANNEL SELECTOR register contents.

Table 8-23. GLOBAL STATUS Register Mapping: Address 0x12

Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Unused											STBY X				

8.7.12 GLOBAL STATUS Register Description

Table 8-24. GLOBAL STATUS Register Description

Bit label	Value	Description	Default Setting
	0	Selected Channel is in standby	0
SIDIX	1	Selected Channel is active	0

8.7.13 TRIMMER Register

Applies to TRIMMER registers A, B, C and D according to CHANNEL SELECTOR register contents.

Table 8-25	TRIMMER	Register	Manning.	Address	0x13
Table 0-23.		negister	wapping.	Audiess	0110

Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0			
					Unuse	ed			Unused									

Bit label	Value	Description	Default Setting			
	0000	+11.71Ω				
	0001	+9.95Ω				
	0010	+8.29Ω				
	0011	+6.71Ω				
	0100	+5.23Ω				
	0101	+3.82Ω				
	0110	+2.48Ω	1000 +0Ω			
TRIMMER X	1000	+1.21Ω				
<3:0>	1000	0.00Ω				
	1001	-1.15Ω				
	1010	-2.25Ω				
	1011	-3.30Ω				
	1100	-4.31Ω				
	1101	-5.27Ω				
	1110	-6.18Ω				
	1111	-7.07Ω	1			

Table 8-26. TRIMMER Register Description

- Notes: 1. R = 1 + (121*k / (2 + 0.006*(8*bit3 + 4*bit2 + 2*bit1 + bit0))) the practical results (simulated) are not exactly the ones given above.
 - 2. Please refer to Section 8.6 for more information.

8.7.14 External Offset Registers

Applies to External Offset Registers A, B, C and D according to CHANNEL SELECTOR register contents.

Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
			Unus	ed					E	XTERN	IAL OFF	SET X	<7:0> (1)	

Table 8-28. External Offset Control Register Description

Bit label	Value	Description	Default Setting
	0x00	Maximum negative offset applied	
EXTERNAL	0x7F	Minimum negative offset applied	0x800 LSB
<7:0>	0x80	Minimum positive offset applied	Offset
	0xFF	Maximum positive offset applied	

Notes: 1. Offset variation range: ~± 50 mV, 256 steps (1 step ~0.4 mV ~0.2 LSB).

2. Current offset of the selected channel is controlled by the External Offset Control Register but is updated only upon request placed through the SPI in the CAL control register of the selected channel.

8.7.15 Offset Registers (Read Only)

Applies to offset registers A, B, C and D according to CHANNEL SELECTOR register contents.

Table 8-29.	Offset Control Register Mapping: Address 0x2	21

Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
			Unu	sed						EXTER		FSET X	< <7:0> (1)(2)	

Table 8-30. External Offset Control Register Description

Bit label	Value	Description	Default Setting
	0x00	Maximum negative offset applied	
OFFSET X	0x7F	Minimum negative offset applied	0x80
<7:0	0x80	Minimum positive offset applied	0 LSB Offset
	0xFF	Maximum positive offset applied	Ť

Notes: 1. Offset variation range: ~± 50 mV, 256 steps (1 step ~0.4 mV ~0.2 LSB).

2. Current offset of the selected channel is controlled by the External Offset Control Register but is updated only upon request placed through the SPI in the CAL control register of the selected channel.

8.7.16 External Gain Control Registers

Applies to External Gain Control registers A, B, C and D according to CHANNEL SELECTOR register contents.

 Table 8-31.
 External Gain Control Register Mapping: Address 0x22

Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
			Unu	sed						EXTE	ERNAL (GAIN X	<7:0> ⁽¹⁾⁽	2)	

Table 8-32. External Gain Control Register Description

Bit label	Value	Description	Default Setting
	0x00	Gain shrunk to minimum accessible value	
	0x80	Gain at default value (no correction, actual gain follow process scattering)	0x80
GAIN X <7:0>			0 dB gain
	0xFF	Gain increased to maximum accessible value	Ì

Notes: 1. Gain variation range: ~±18%, 255 steps (1 step ~0.14%).

2. Current gain of the selected channel is controlled by the External Gain Control Register but is updated only upon request placed through the SPI in the CAL control register of the selected channel.

8.7.17 Gain Control Registers (Read Only)

Applies to gain control registers A, B, C and D according to CHANNEL SELECTOR register contents.

 Table 8-33.
 Gain Control Register Mapping: Address 0x23

Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
			Unu	sed							GAIN X	< <7:0> ((1)(2)		

Table 8-34. Gain Control Register Description

Bit Label	Value	Description	Default Setting
	0x00	Gain shrunk to minimum accessible value	
GAIN X <7:0>	0x80	Gain at default value (no correction, actual gain follow process scattering)	0x80
			0 dB gain
	0xFF	Gain increased to max accessible value	

Notes: 1. Gain variation range: ~±18%, 255 steps (1 step ~0.14%).

2. Current gain of the selected channel is controlled by the external gain control register but is updated only upon request placed through the SPI in the CAL control register of the selected channel.

8.7.18 External Phase Registers

Applies to phase registers A, B, C and D according to CHANNEL SELECTOR register contents.

Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
			Unu	sed						EXTER	RNAL PI	HASE X	<7:0> ⁽¹)(2)	

Table 8-36.	External Phase Control Register	Description
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Bit label	Value	Description	Default Setting
	0x00	~-14 ps correction on selected channel aperture delay	0x80
EXTERNAL PHASE X <7:0>		Ops correction on ADC X aperture	
	0xFF	~ +14 ps correction on selected channel aperture delay	Delay

Notes: 1. Delay control range for edges of internal sampling clocks: ~±14 ps (1 step ~110 fs).

2. Actual Aperture Delay of the selected channel is controlled by the External Phase Control Register but is updated only upon request placed through the SPI in the CAL control register of the selected channel.

8.7.19 Phase Registers (Read Only)

Applies to Phase Registers A, B, C and D according to CHANNEL SELECTOR register contents.

Table 0-07. I hase negister mapping. Address 0.2	Table 8-37.	Phase Register Mapping: Address 0x25
--	-------------	--------------------------------------

Bit 15 Bit 14 Bit 13 Bit 12 Bit 11 Bit 10 Bit 9 Bit 8							Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	
Unused							PHASE X <7:0> (1)(2)								

Table 8-38. Phase Control Register Description

Bit label	Value	Description	Default Setting			
	0x00	\sim -14 ps correction on selected channel aperture delay	0x80			
PHASE X <7:0>			Ops correction			
	0xFF	0xFF ~+14 ps correction on selected channel aperture delay				

Notes: 1. Delay control range for edges of internal sampling clocks: ~±14 ps (1 step ~110 fs).

2. Actual Aperture Delay of the selected channel is controlled by the External Phase Control Register but is updated only upon request placed through the SPI in the CAL control register of the selected channel.

8.7.20 External First level INL Registers

Applies to External first level INL registers A, B, C and D according to CHANNEL SELECTOR register contents.

Table 8-39.	External First level INL	Register Mapping:	Address	0x30 to	0x31
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Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
EXTERNAL INL1 X <15:0> (1)(2)															

Table 8-40. External First level INL Register Description

Bit label	Value	Description	Default Setting
	0x0000		
EXTERNAL INL1			02000
X <15:0>			0x0000
	0XFFFF		

 Table 8-41.
 External First level INL Register Mapping: Address 0x32

Bit 15 Bit 14 Bit 13 Bit 12 Bit 11 Bit 10 Bit 9 Bit 8								Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
EXTERNAL INL1 X <7:0> (1)										[оо пот	USE (C)x00)		

Bit label	Value	Description	Default Setting
	0x00		
EXTERNAL INL1			0.00
X <7:0>			0000
	0XFF		*

Table 8-42.	External First level INL	Register Description
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- Notes: 1. Actual first level INL of the selected channel is controlled by the transfer of External first level INL Register (addresses 0x30 to 0x32) upon request placed through the SPI in the CAL control register of the selected channel.
 - 2. Refer to the INL Calibration procedure for more information.

8.7.21 External Second Level INL Registers

Applies to External second level INL registers A, B, C and D according to CHANNEL SELECTOR register contents.

Table 8-43.	External Second level INL Register Mapping: Address 0x33 to 0x34

Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
	EXTERNAL INL2 X <15:0> ⁽¹⁾														

Table 8-44. External Second Level INL Register Description

Bit label	Value	Description	Default Setting
	0x0000		
EXTERNAL INL2			0×0000
X <15:0>			00000
	0XFFFF		

Table 8-45.	External Second level INL	Register Mapping:	Address 0x35
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Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
EXTERNAL INL2 X <7:0> (1)										[DO NOT	USE (0	x00)		

Table 8-46. External Second Level INL Register Description

Bit label	Value	Description	Default Setting
	0x00		
EXTERNAL INL2			0200
X <7:0>			0x00
	0XFF		

- Notes: 1. Actual second level INL of the selected channel is controlled by the transfer of External second level INL Register (addresses 0x33 to 0x35) upon request placed through the SPI in the CAL control register of the selected channel.
 - 2. Refer to the INL Calibration procedure for more information.

8.7.22 First Level INL Registers (Read only)

Applies to first level INL registers A, B, C and D according to CHANNEL SELECTOR register contents.

Table 8-47.	First Level INL	Register Mapping:	Address 0x36 to 0x38
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Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
	INL1 X <15:0>														

Table 8-48. First Level INL Register Description

Bit label	Value	Description	Default Setting
	0x0000		
INI 1 X <15:0>			0x0000
			0,0000
	0XFFFF		

8.7.23 Second Level INL Registers (Read only)

Applies to second level INL registers A, B, C and D according to CHANNEL SELECTOR register contents.

Table 8-49. Second Level INL Register Mapping: Address 0x39 to 0x3B

Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
	INL2 X <15:0>														

 Table 8-50.
 Second Level INL Register Description

Bit label	Value	Description	Default Setting
	0x0000		
INL2 X <15:0>			0,0000
			0x0000
	0XFFFF		

8.8 INL Calibration Procedure

The calibration of the INL abides by the following rule:

If there is an INL peak (+0.5 LSB) around a specific code, then this peak can be decreased by 0.15 LSB by writing a "1" on the bit given by the table below for the first level of correction (fifth column). If this is not sufficient to decrease the INL peak, then you can write a "1" on the bit given by the table in the first level INL column (fourth column). The effect will be then to decrease the INL by 0.6 LSB (the effect of columns four and five are added).

The procedure is similar when the INL should be increased (columns one and two).

Example:

The intrinsic INL obtained with the ADC has a peak (+0.5 LSB) around code 128. By writing a "1" on bit 9 of register at address 0x34, you will be able to decrease the INL peak. If this is not sufficient, you can write another "1" on bit 9 at address 0x31.

Table 8-51. INL	Calibration Table
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	First Level INL	Second Level INL	First Level INL	Second Level INL	
INL Code	Increase by 0.45 LSB	Increase by 0.15 LSB	Decrease by 0.45 LSB	Decrease by 0.15 LSB	
0	0x32 bit 8	0x35 bit 8	0x32 bit 9	0x35 bit 9	
16	0x32 bit 10	0x35 bit 10	0x32 bit 11	0x35 bit 11	
32	0x32 bit 12	0x35 bit 12	0x32 bit 13	0x35 bit 13	
48	0x32 bit 14	0x35 bit 14	0x32 bit 15	0x35 bit 15	
64	0x31 bit 0	0x34 bit 0	0x31 bit 1	0x34 bit 1	
80	0x31 bit 2	0x34 bit 2	0x31 bit 3	0x34 bit 3	
96	0x31 bit 4	0x34 bit 4	0x31 bit 5	0x34 bit 5	
112	0x31 bit 6	0x34 bit 6	0x31 bit 7	0x34 bit 7	
128	0x31 bit 8	0x34 bit 8	0x31 bit 9	0x34 bit 9	
144	0x31 bit 10	0x34 bit 10	0x31 bit 11	0x34 bit 11	
160	0x31 bit 12	0x34 bit 12	0x31 bit 13	0x34 bit 13	
176	0x31 bit 14	0x34 bit 14	0x31 bit 15	0x34 bit 15	
192	0x30 bit 0	0x33 bit 0	0x30 bit 1	0x33 bit 1	
208	0x30 bit 2	0x33 bit 2	0x30 bit 3	0x33 bit 3	
224	0x30 bit 4	0x33 bit 4	0x30 bit 5	0x33 bit 5	
240	0x30 bit 6	0x33 bit 6	0x30 bit 7	0x33 bit 7	
255	0x30 bit 8	0x33 bit 8	0x30 bit 9	0x33 bit 9	

Note: The INL correction value varies with the temperature. The typical value is 0.15 LSB at $T_J = 50^{\circ}$ C but can vary from 0.1 LSB to 0.2 LSB from low to high temperatures.

8.8.1 Timings

Note: Last falling edge of sclk should occur only once csn is back to high level at the end of the write procedure

Note: $T_{CSN_END} = T_{SCLK}/4 = 12.5 \text{ ns}$ (see note ⁽³⁾).

Table 8-52.	Timing Characteris	stics
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Pin	Max Frequency	Setup ⁽¹⁾	Hold ⁽¹⁾
SCLK	20 MHz		
CSN (to SCLK) (2)		0.5 ns/1 ns	0.5 ns/1 ns
MOSI (to SCLK)		0.5 ns/1.2 ns	0.5 ns/1.0 ns
MISO (to SCLK)		1.5 ns/4 ns	1.7 ns/3.5 ns

Notes: 1. First value is in minimum conditions, second value is in maximum conditions.

- 2. Setup/Hold to both SCLK edges.
- 3. Last falling edge of sclk should occur once csn is set to 1, due to an internal operation.

9. Definition of Terms

Table 9-1.Definition of Terms

(Fs max)	Maximum Sampling Frequency	Sampling Frequency for Which ENOB < 6bits
(Fs min)	Minimum sampling frequency	Sampling frequency for which the ADC Gain has fallen by 0.5 dB with respect to the gain reference value. Performances are not guaranteed below this frequency.
(BER)	Bit Error Rate	Probability to exceed a specified error threshold for a sample at maximum specified sampling rate. An error code is a code that differs by more than ± 4 LSB from the correct code.
(FPBW)	Full power input bandwidth	Analog input frequency at which the fundamental component in the digitally reconstructed output waveform has fallen by 3 dB with respect to its low frequency value (determined by FFT analysis) for input at full scale -1 dB (-1 dBFS).
(SSBW)	Small signal input bandwidth	Analog input frequency at which the fundamental component in the digitally reconstructed output waveform has fallen by 3 dB with respect to its low frequency value (determined by FFT analysis) for input at full scale –10 dB (–10 dBFS).
(SINAD)	Signal-to-noise and distortion ratio	Ratio expressed in dB of the RMS signal amplitude, set to 1dB below full scale (-1dBFS), to the RMS sum of all other spectral components, including the harmonics except DC.
(SNR)	Signal-to-noise ratio	Ratio expressed in dB of the RMS signal amplitude, set to 1dB below full scale, to the RMS sum of all other spectral components including the nine first harmonics.
(THD)	Total harmonic distortion	Ratio expressed in dB of the RMS sum of the first nine harmonic components, to the RMS input signal amplitude, set at 1 dB below full scale. It may be reported in dB (that is, related to converter –1 dB full scale), or in dBc (i.e, related to input signal level).
(SFDR)	Spurious free dynamic range	Ratio expressed in dB of the RMS signal amplitude, set at 1dB below full scale, to the RMS value of the highest spectral component (peak spurious spectral component). The peak spurious component may or may not be a harmonic. It may be reported in dB (that is, related to converter –1 dB full scale), or in dBc (that is, related to input signal level).
(ENOB)	Effective number of bits	$ENOB = \frac{SINAD - 1.76 + 20\log(A/FS/2)}{6.02}$ Where A is the actual input amplitude and FS is the full scale range of the ADC under test.
(DNL)	Differential nonlinearity	The Differential Non Linearity for an output code i is the difference between the measured step size of code i and the ideal LSB step size. DNL (i) is expressed in LSBs. DNL is the maximum value of all DNL (i). DNL error specification of less than 1 LSB guarantees that there are no missing output codes and that the transfer function is monotonic.
(INL)	Integral nonlinearity	The Integral Non Linearity for an output code i is the difference between the measured input voltage at which the transition occurs and the ideal value of this transition. INL (i) is expressed in LSBs, and is the maximum value of all INL (i).
(TA)	Aperture delay	Delay between the rising edge of the differential clock inputs (CLK, CLKN) (zero crossing point), and the time at which (XAI, XAIN, where $X = A, B, C, D$) is sampled.
(JITTER)	Aperture uncertainty	Sample to sample variation in aperture delay. The voltage error due to jitter depends on the slew rate of the signal at the sampling point.
(TS)	Settling time	Time delay to achieve 0.8% accuracy at the converter output when a 80% full scale step function is applied to the differential analog input.
(ORT)	Overvoltage recovery time	Time to recover 0.8% accuracy at the output, after a 150% full scale step applied on the input is reduced to midscale.
(TOD)	Digital data output delay	Delay from the rising edge of the differential clock inputs (CLK, CLKN) (zero crossing point) to the next point of change in the differential output data (zero crossing) with specified load.
(TDR)	Data ready output delay	Delay from the rising edge of the differential clock inputs (CLK, CLKN) (zero crossing point) to the next point of change in the differential output data (zero crossing) with specified load.
(TD1)	Time delay from data transition to data ready	General expression is TD1 = TC1 + TDR – TOD with TC = TC1 + TC2 = 1 encoding clock period.

(Fs max)	Maximum Sampling Frequency	Sampling Frequency for Which ENOB < 6bits
(TD2)	Time delay from data ready to data	General expression is $TD2 = TC2 + TDR - TOD$ with $TC = TC1 + TC2 = 1$ encoding clock period.
(TC)	Encoding clock period	TC1 = Minimum clock pulse width (high) TC = TC1 + TC2 TC2 = Minimum clock pulse width (low)
(TPD)	Pipeline Delay	Number of clock cycles between the sampling edge of an input data and the associated output data being made available, (not taking in account the TOD).
(TRDR)	Data ready reset delay	Delay between the first rising edge of the external clock after reset (SYNC, SYNCN) and the reset to digital zero transition of the data ready output signal (XDR, XDRN, where X = A, B, C or D).
(TR)	Rise time	Time delay for the output DATA signals to rise from 20% to 80% of delta between low level and high level.
(TF)	Fall time	Time delay for the output DATA signals to fall from 20% to 80% of delta between low level and high level.
(PSRR)	Power supply rejection ratio	Ratio of input offset variation to a change in power supply voltage.
(NRZ)	Nonreturn to zero	When the input signal is larger than the upper bound of the ADC input range, the output code is identical to the maximum code and the out-of-range bit is set to logic one. When the input signal is smaller than the lower bound of the ADC input range, the output code is identical to the minimum code, and the out-of-range bit is set to logic one. (It is assumed that the input signal amplitude remains within the absolute maximum ratings).
(IMD)	Intermodulation distortion	The two tones intermodulation distortion (IMD) rejection is the ratio of either input tone to the worst third order intermodulation products.
(NPR)	Noise power ratio	The NPR is measured to characterize the ADC performance in response to broad bandwidth signals. When applying a notch-filtered broadband white-noise signal as the input to the ADC under test, the Noise Power Ratio is defined as the ratio of the average out-of-notch to the average in-notch power spectral density magnitudes for the FFT spectrum of the ADC output sample test.
(VSWR)	Voltage standing wave ratio	The VSWR corresponds to the ADC input insertion loss due to input power reflection. For example a VSWR of 1.2 corresponds to a 20 dB return loss (ie. 99% power transmitted and 1% reflected).

Table 9-1. Definition of Terms (Continued)

10. Thermal and Moisture Characteristics

Assumptions:

- No air
- Pure conduction
- No radiation

10.1 Thermal Characteristics

- Rth Junction bottom of balls = $4.47^{\circ}C/W$
- Rth Junction board = 5.28° C/W
- Rth Junction top of case = $2.0^{\circ}C/W$
- Rth Junction top of case with 50 μ m thermal grease = 2.7°C/W
- Rth Junction ambient (JEDEC standard, 49 × 49 mm² board size) = 14.1°C/W
- Rth Junction ambient (180 × 170 mm² evaluation board size) = 10.6°C/W

10.2 Thermal Management Recommendations

In still air and 25°C ambient temperature conditions, the maximum temperature for the device soldered on the evaluation board is 67.4°C. In this environment, no cooling is necessary. In the case of the need of an external thermal management, it is recommended to have an external heatsink on top of the EBGA380 with a thermal resistance of 5°C/W max.

10.3 Moisture Characteristics

This device is sensitive to the moisture (MSL3 according to JEDEC standard). Shelf life in sealed bag: 12 months at <40°C and <90% relative humidity (RH). After this bag is opened, devices that will be subjected to infrared reflow, vapor-phase reflow, or equivalent processing (peak package body temp. 220°C) must be:

- Mounted within 168 hours at factory conditions of ≤30°C/60% RH, or
- Stored at ≤20% RH

Devices require baking, before mounting, if Humidity Indicator is >20% when read at 23°C \pm 5°C. If baking is required, devices may be baked for:

- 192 hours at 40°C + 5°C/-0°C and <5% RH for low temperature device containers, or
- 24 hours at $125^{\circ}C \pm 5^{\circ}C$ for high-temperature device containers

11. Quad ADC Application Information

11.1 Bypassing, Decoupling and Grounding

All power supplies have to be decoupled to ground as close as possible to the signal accesses to the board by 1 μ F in parallel to 100 nF.

Note: V_{CCD} and V_{CCO} planes should be separated but the two power supplies can be reunited by a strap on the board.

Each group of neighboring power supply pins attributed to the same value should be bypassed with at least one pair of 100 pF in parallel to 10 nF capacitors. These capacitors should be placed as close as possible to the power supply package pins.

The minimum required number of pairs of capacitors by power supply type is:

- -25 for V_{CC} -2 for V_{CCD}
- 12 for V_{CCO}
Figure 11-2. EV8AQ160 Power Supplies Bypassing Scheme



11.2 Analog Inputs (V_{IN}/V_{INN})

11.2.1 Differential Analog Input

Differential mode is the recommended input scheme. A balun can be used to convert a single-ended source to a differential signal for use with this ADC. The analog input can be either DC or AC coupled as described in Figure 11-3 and Figure 11-4.





- Notes: 1. X = A, B, C or D.
 - 2. 2. The 50Ω terminations are implemented on-chip and can be fine tuned (TRIMMER register at address 0x13).
 - 3. CMIRefAB/CD = 1.8V. This Common mode is output on signal CMIRefAB for A and B channels and CMIRefCD for C and D channels.



Figure 11-4. Differential Analog Input Implementation (DC Coupled)

- Notes: 1. X = A, B, C or D.
 - The 50Ω terminations are implemented on-chip and can be fine tuned (TRIMMER register at address 0x13).
 - 3. CMIRefAB/CD = 1.8V. This Common mode is output on signal CMIRefAB for A and B channels and CMIRefCD for C and D channels.

11.3 Clock Inputs (CLK/CLKN)

Differential mode is the recommended input scheme.Single-ended clock input is not recommended due to performance limitations. Since the clock input common mode is 1.8V, we recommend to AC couple the input clock as described in Figure 11-5.





11.4 Digital Outputs

The digital outputs are LVDS compatible. They have to be 100Ω differentially terminated.





11.5 Reset Buffer (SYNCP, SYNCN)







12. EBGA380 Quad ADC Package Outline



Figure 12-1. EBGA380 Quad ADC Package Outline

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TOP VIEW \bigcirc Α С В BOTTOM VIEW 16 14 12 10 24 22 20 18 D \bigcirc 1 e AB AC AD Ε LAND PATTERN RECOMMENDATIONS . • h D Îе e

Е

Figure 12-2. EBGA380 Land Pattern Recommendation

А	В	С	D	Е	е	b
31.00	31.00	0.85	29.21	29.21	1.27	0.70

All dimensions are in millimeters

13. Ordering Information

Table 13-1.	Ordering Information

Part Number	Package	Temperature Range	Screening Level	Comments
EVX8AQ160TPY	EBGA380 RoHS	Ambient	Prototype	
EV8AQ160CTPY	EBGA380 RoHS	Commercial <i>C</i> grade 0°C < T _{amb} < 70°C	Standard	
EV8AQ160TPY-EB	EBGA380 RoHS	Ambient	Prototype	Evaluation board

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